

CD1030

33-channel multiple switch detection interface with programmable wetting current

Rev. 6.0 — 20 August 2024

Product data sheet

1 General description

The CD1030 is designed to detect the closing and opening of up to 33 switch contacts. The switch status, either open or closed, is transferred to the microprocessor unit (MCU) through a serial peripheral interface (SPI). This SMARTMOS device also features a 35-to-1 analog multiplexer for reading the input channels as analog inputs. The analog selected input signal is buffered and provided on the AMUX output pin for the MCU to read.

Independent programmable wetting currents are available as needed for the application. A battery and temperature monitor are included in the IC and available via the AMUX pin.

The CD1030 device has several modes of operation: Normal mode, Low-power mode (LPM), and Polling mode. Normal mode allows programming of the device and supplies switch contacts with pullup or pulldown current as it monitors the change of state on the switches. The LPM provides low quiescent current, which makes the CD1030 ideal for automotive and industrial products requiring low sleep-state currents. Polling mode periodically interrogates the input pins to determine the state the pins are in, and to decide whether there was a change of state from Normal mode.



2 Features and benefits

- Fully functional operation from 4.5 V to 36 V
- Full parametric operation from 6.0 V to 28 V
- Low-power mode current $I_{BATP} = 50 \mu A$ and $I_{DDQ} = 10 \mu A$
- 33 switch detection channels
 - 21 switch-to-Ground (SG) inputs with configurable pull-up current sources
 - 12 programmable switch (SP) inputs
 - Switch-to-Ground (SG) or Switch-to-Battery (SB)
 - Operating switch input voltage range from -1.0 V to 36 V
 - Selectable wetting current (2.0, 6.0, 8.0, 10, 12, 14, 16, or 20 mA)
 - Programmable wetting operation (Pulse or continuous)
 - Selectable wake-up on change of state
- 35 to 1 Analog Multiplexer
 - Buffered AMUX output from SG/SP channels
 - Integrated divider by six on SG5 for battery voltage sensing
 - Integrated die temperature sensing through AMUX output
 - Optional two or three pin hardwire AMUX selection
- Active interrupt (INT_B) on switch's change of state
- Direct MCU Interface through 3.3 V / 5.0 V SPI protocol

3 Ordering information

This section describes the part numbers available to be purchased along with their differences.

Table 1. Orderable part variations

| Part number | Temperature (T _A) | Package | Notes |
|---|-------------------------------|--------------|---------------------|
| MC33CD1030AE | -40 °C to 125 °C | LQFP 48 pins | (1) |
| Notes | | | |
| 1. To order parts in tape and reel, add the R2 suffix to the part number. | | | |

4 Functional block diagram

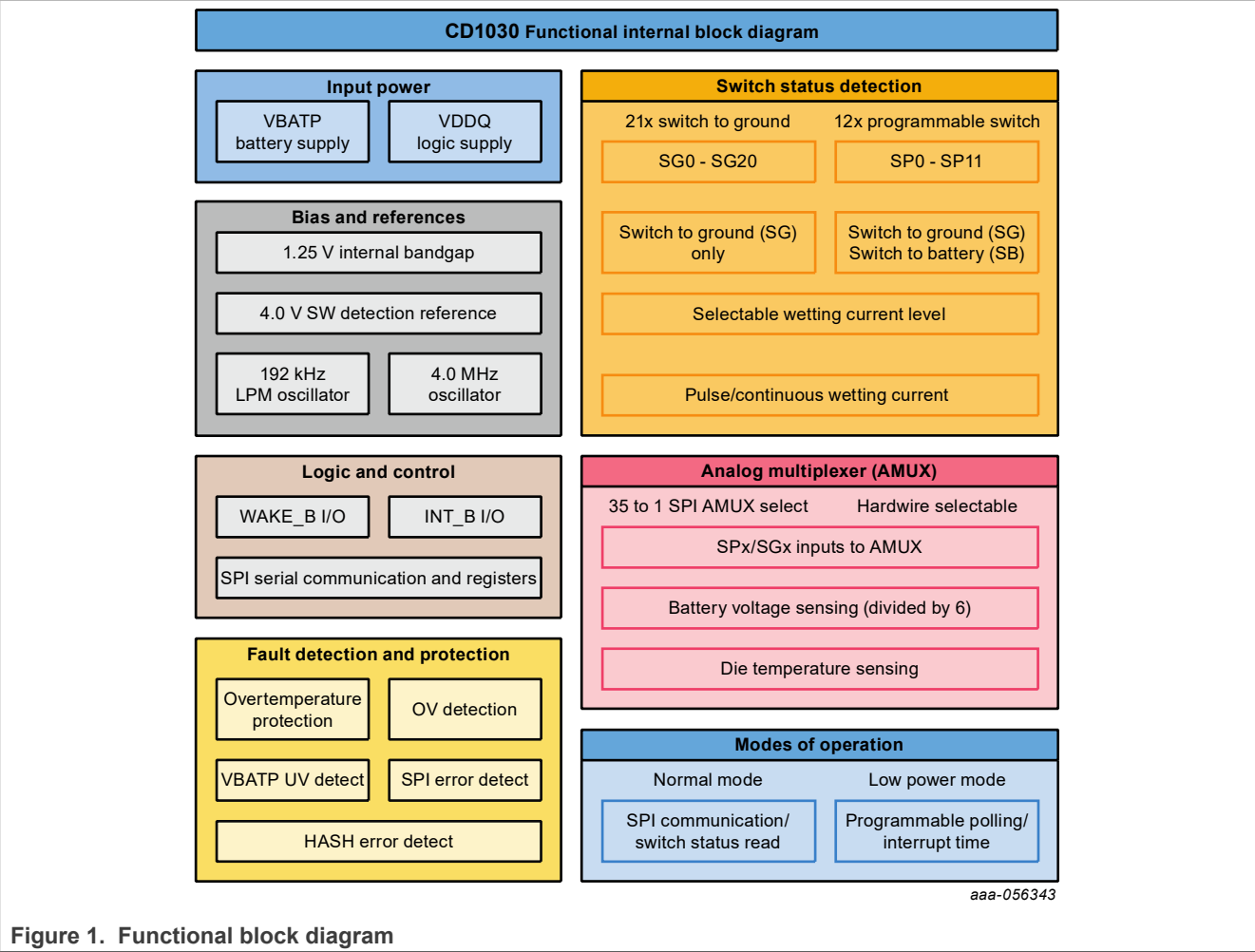


Figure 1. Functional block diagram

5 Internal block diagram

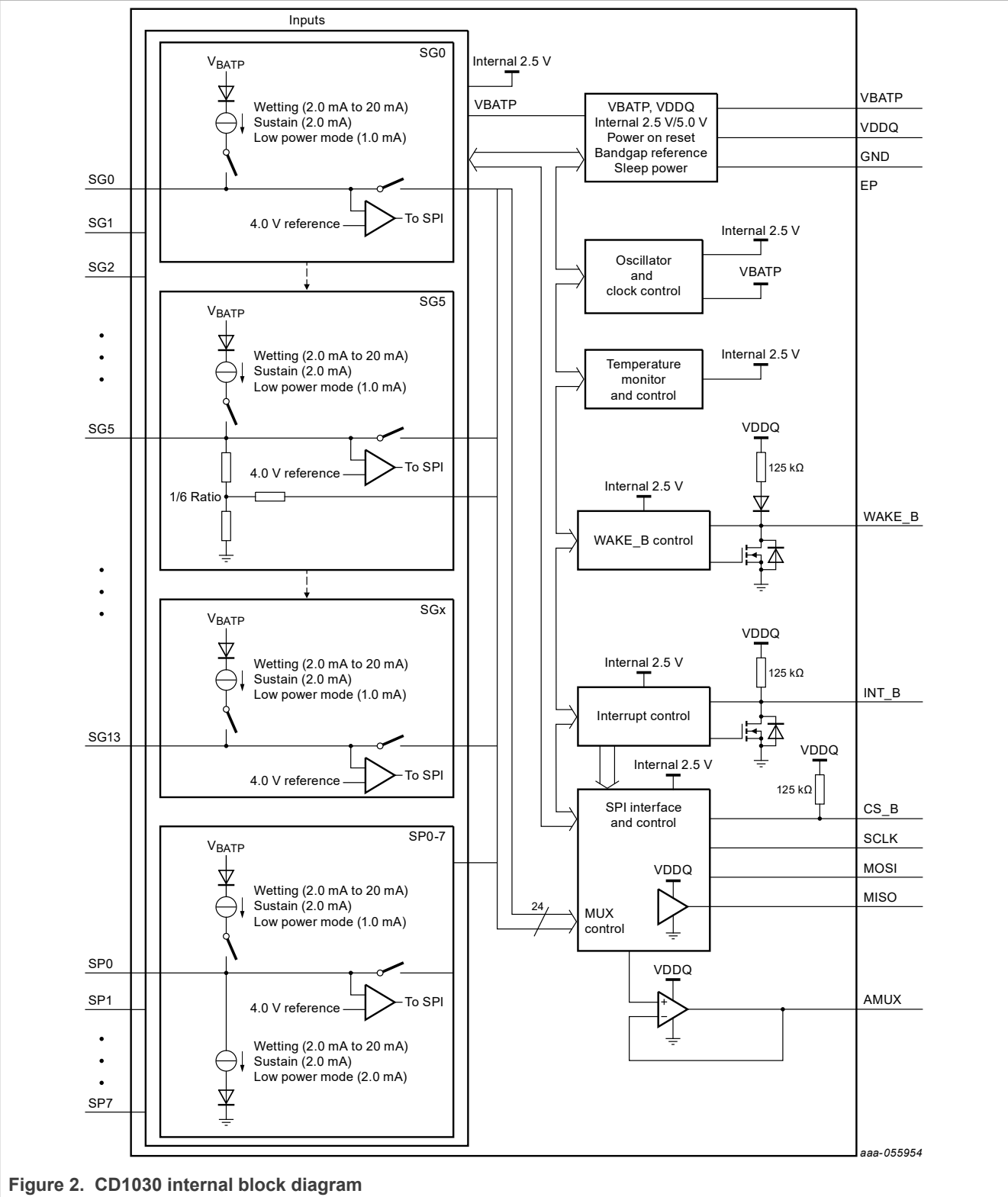
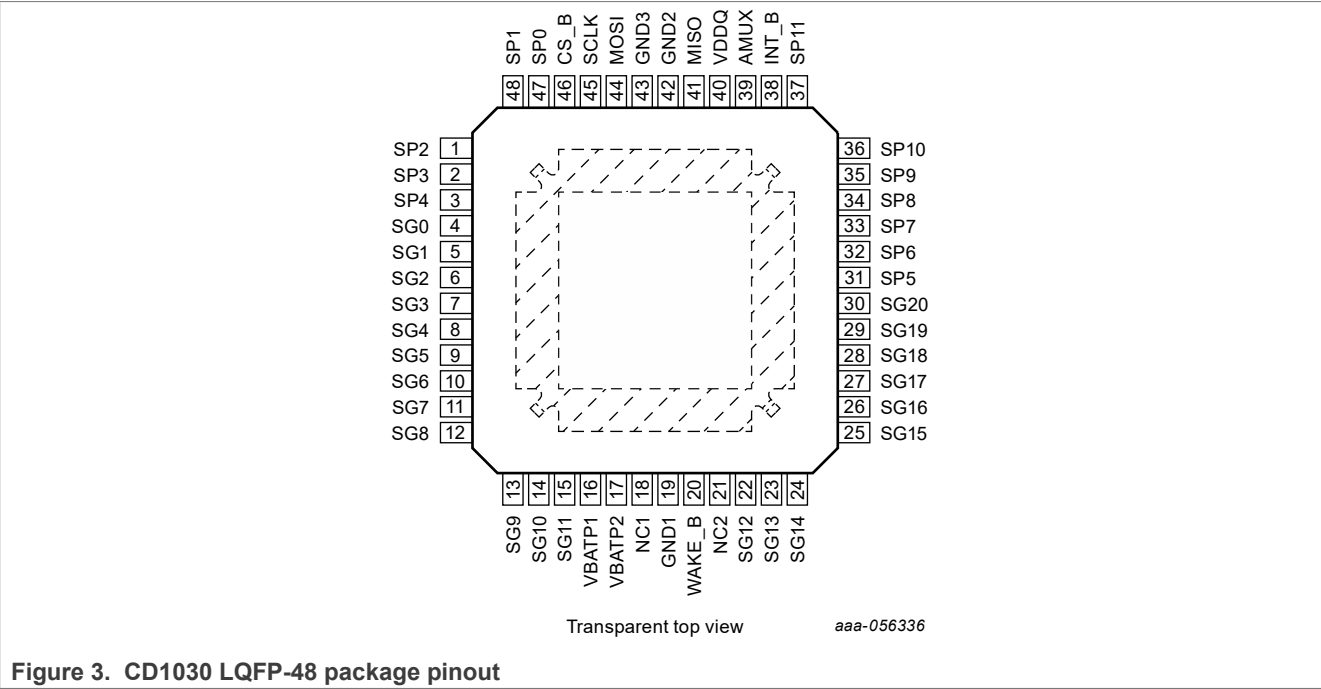


Figure 2. CD1030 internal block diagram

6 Pinning information

6.1 Pinout



6.2 Pin definitions

Table 2. CD1030 pin definitions

| Pin number | Pin name | Function | Formal name | Definition |
|-------------------|-------------------------|------------------|--------------------------------|---|
| 1 - 3 47 48 | SP2 - SP4 SP0 SP1 | Input | Programmable Switches 0 – 4 | Switch to programmable input pins (SB or SG) |
| 4 - 15 | SG0 - SG11 | Input | Switch-to-Ground Inputs 0 – 11 | Switch-to-ground input pins |
| 18 | NC1 | - | Not Connect | Not connect |
| 19 | GND1 | Ground | Ground | Ground for logic, analog |
| 20 | WAKE_B | Input/ Output | Wake-up | Open drain wake-up output. Designed to control a power supply enable pin. Input used to allow a wake-up from an external event. |
| 21 | NC2 | - | Not Connect | Not connect |
| 22 - 30 | SG12 - SG20 | Input | Switch-to-Ground Inputs 12– 20 | Switch-to-ground input pins |
| 31 - 37 | SP5 - SP11 | Input | Programmable Switches 5 – 11 | Switch to programmable input pins (SB or SG) |
| 38 | INT_B | Input/ Output | Interrupt | Open-drain output to MCU. Used to indicate an input switch change of state. Used as an input to allow wake-up from LPM via an external INT_B falling event. |

Table 2. CD1030 pin definitions...continued

| Pin number | Pin name | Function | Formal name | Definition |
|------------|------------------|------------|-------------------------|--|
| 39 | AMUX | Output | Analog Multiplex Output | Analog multiplex output. |
| 40 | VDDQ | Input | Voltage Drain Supply | 3.3 V/ 5.0 V supply. Sets SPI communication level for the MISO driver and I/O level buffer |
| 41 | MISO | Output/SPI | SPI Secondary Out | Provides digital data from the CD1030 to the MCU |
| 44 | MOSI | Input/SPI | SPI Secondary In | SPI control data input pin from the MCU |
| 45 | SCLK | Input/SPI | Serial Clock | SPI control clock input pin |
| 46 | CS_B | Input/SPI | Chip Select | SPI control chip select input pin |
| 16 17 | VBATP1 VBATP2 | Power | Battery Input | Battery supply input pin. Pin requires external reverse battery protection |
| 42 43 | GND2 GND3 | Ground | Ground | Ground for logic, analog |
| EP | EP | Ground | Exposed Pad | It is recommended to terminated the exposed pad to GND and system ground. |

7 General IC functional description

The CD1030 device interacts with many connections outside the module and near the end user. The IC detects changes in switch state and reports the information to the MCU via the SPI protocol. The input pins generally connected to switches located outside the module and in proximity to battery in car harnesses. Consequently, the IC must have some external protection including an ESD capacitor and series resistors, to ensure the energy from the various pulses are limited at the IC.

The IC requires a blocking diode be used on the VBATP pin to protect from a reverse battery condition. The inputs are capable of surviving reverse battery without a blocking diode and also contain an internal blocking diode from the input to the power supply (V_{BATP}). This ensures there is no back feeding of voltage/current into the IC, when the voltage on the input is higher than the VBATP pin.

7.1 Battery voltage ranges

The CD1030 device operates from $4.5\text{ V} \leq V_{BATP} \leq 36\text{ V}$ and is capable of withstanding up to 40 V. The IC operates functionally from $4.5\text{ V} < V_{BATP} < 6.0\text{ V}$, but with degraded parametrics values. Voltages in excess of 40 V must be clamped externally to protect the IC from destruction. The VBATP pin must be isolated from the main battery node by a diode.

7.1.1 Load dump (overvoltage)

During load dump the CD1030 operates properly up to the V_{BATP} overvoltage. Voltages greater than load dump (~32 V) causes the current sources to be limited to ~2.0 mA, but the register values are maintained. Upon leaving this overvoltage condition, the original setup is returned and normal operation begins again.

7.1.2 Jump start (double battery)

During a jump start (double battery) condition, the device must functions normally and meets all the specified parametric values. No internal faults are set and no abnormal operation noted as a result of operating in this range.

7.1.3 Normal battery range

The normal voltage range is fully functional with all parametrics in the given specification.

7.1.4 Low voltage range (degraded parametrics)

In the V_{BATP} range between 4.5 V to 6.0 V the CD1030 functions normally, but has some degraded parametric values. The SPI functions normally with no false reporting. The degraded parameters are noted in [Table 7](#) and [Table 8](#). During this condition, the input comparator threshold is reduced from 4.0 V and remain ratiometrically adjusted, according to the battery level.

7.1.5 Undervoltage lockout

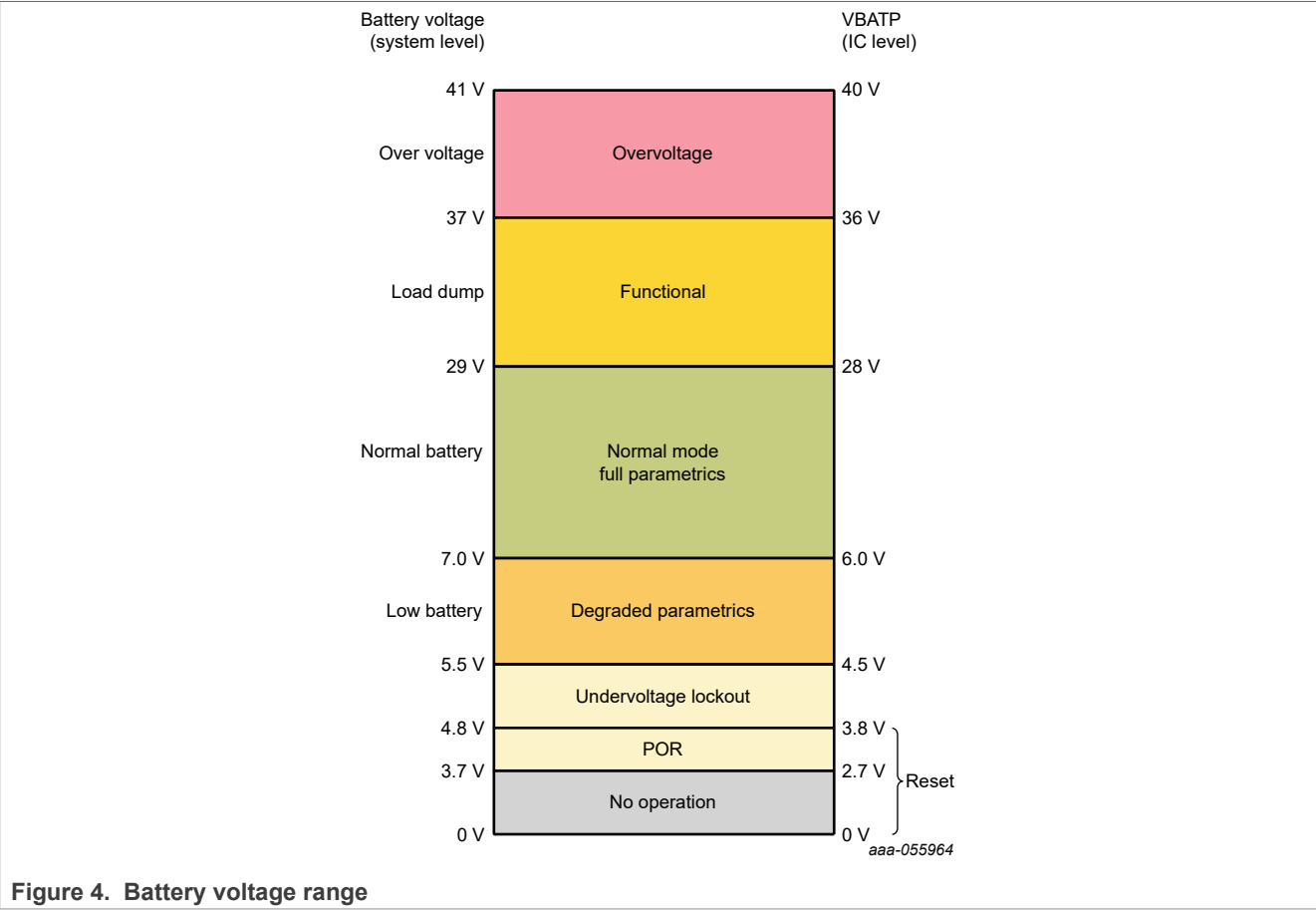
During undervoltage lockout, the MISO output is tristated to avoid any data from being transmitted from the CD1030. Any CS_B pulses are ignored in this voltage range. If the battery enters this range at any point (even during a SPI word), the CD1030 ignores the word and enters lockout mode. A SPI bit register is available to notify the MCU the CD1030 has seen an undervoltage lockout condition, once the battery is high enough to leave this range. During this mode, the input comparator and current sources are turned off.

7.1.6 Power On Reset (POR) activated

The Power on Reset is activated when the VBATP is within the 2.7 V to 3.8 V range. The CD1030 is initialized in undervoltage lockout after the POR is de-asserted. A SPI bit in the device configuration register is used to note a POR occurrence, all SPI registers are reset to the default values, and SPI operation is disabled.

7.1.7 No operation

The device does not function and no switch detection is possible.



7.2 Power sequencing conditions

The chip uses two supplies as inputs into the device for various usage. These pins are VBATP and VDDQ. The VBATP pin is the power supply for the chip where the internal supplies are generated and power supply for the SG circuits. The VDDQ pin is used for the I/O buffer supply to talk to the MCU or other logic level devices, as well as AMUX. The INT_B pin is held low upon POR until the IC is ready to operate and communicate. Power can be applied in various ways to the CD1030 and the following conditions are possible.

7.2.1 V_{BATP} before V_{DDQ}

The normal condition for operation is the application of V_{BATP} and then V_{DDQ}. The chip operates logically in the default state, but without the ability to drive logic pins. When the V_{DDQ} supply is available, the chip is able to communicate correctly. The IC maintains its logical state (register settings) with functional behavior consistent with the logical state. No SPI communications can occur.

7.2.2 V_{DDQ} before V_{BATP}

In some cases, the V_{DDQ} supply may be available before the V_{BATP} supply is ready. There is no back feeding current into the V_{DDQ} pin which could potentially turn on the device into an unknown state, in this scenario. V_{DDQ} is isolated from V_{BATP} circuits and the device is off until V_{BATP} is applied. When V_{BATP} is available the device powers up the internal rails and logic within t_{ACTIVE} time. Communication is undefined until the t_{ACTIVE} time and becomes available after this time frame.

7.2.3 V_{BATP} okay, V_{DDQ} lost

After power up, it is possible the V_{DDQ} may turn off or be lost. In this case, the chip remains in the current state, but is not able to communicate. After the V_{DDQ} pin is available again, the chip is ready to communicate.

7.2.4 V_{DDQ} okay, V_{BATP} lost

After power up, the V_{BATP} supply could be lost. The operation is consistent when V_{DDQ} is available before V_{BATP} .

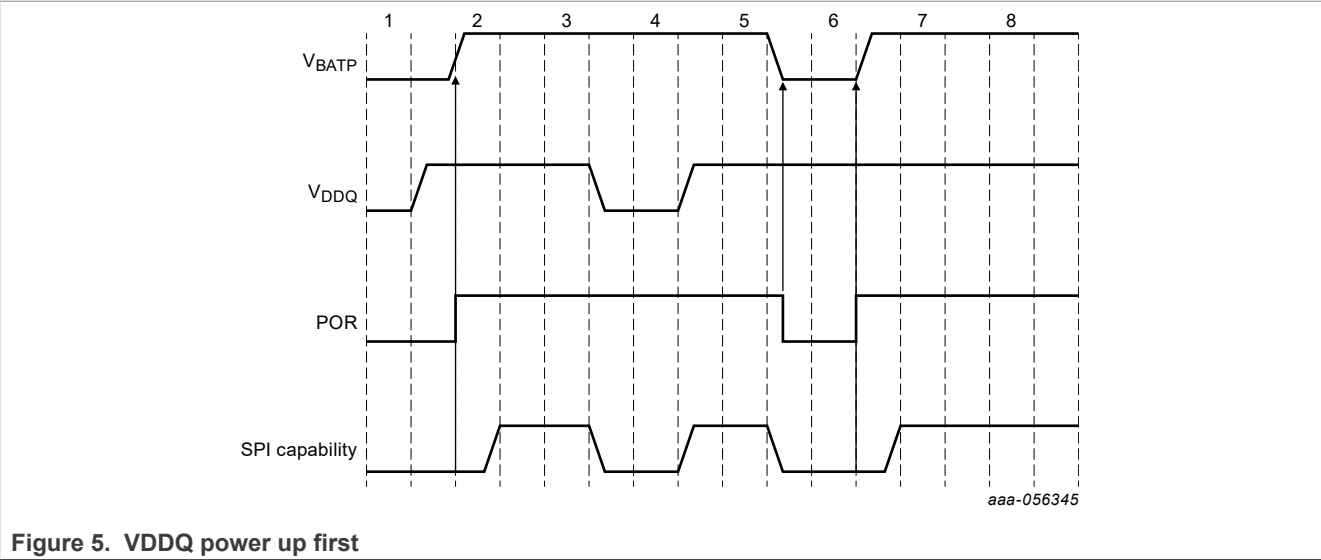


Figure 5. V_{DDQ} power up first

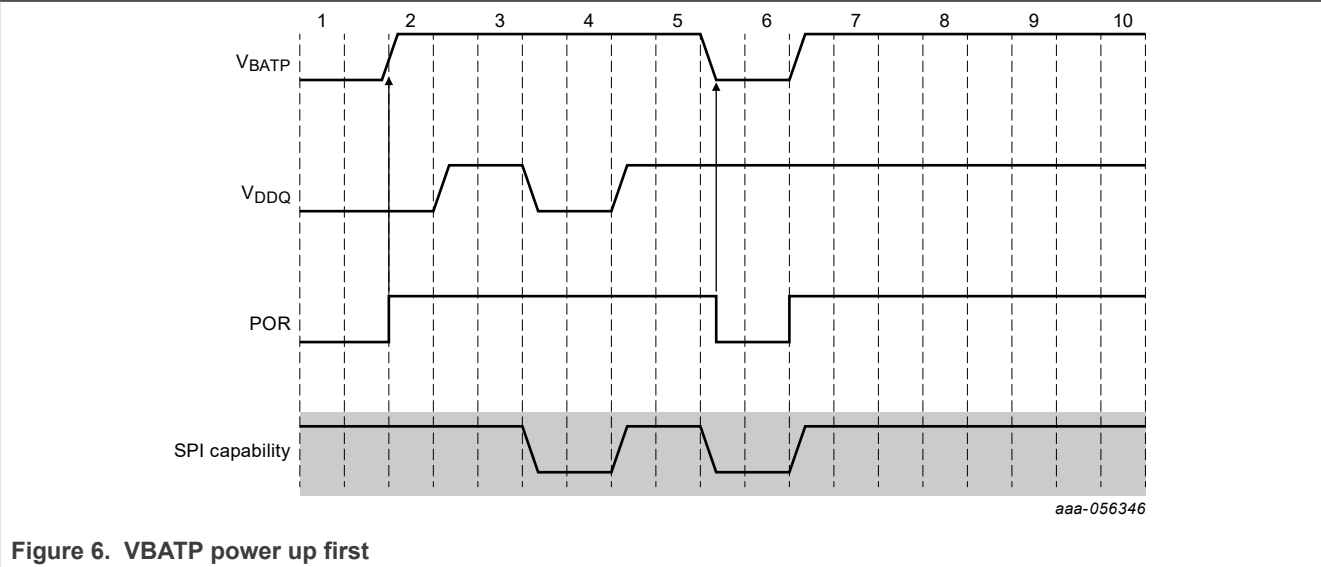
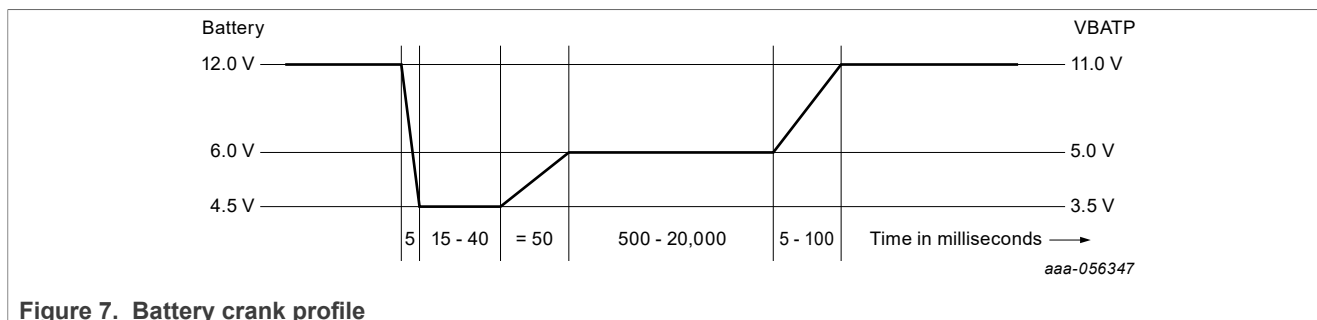


Figure 6. V_{BATP} power up first



7.3 Low-power mode operation

Low-power mode (LPM) is used to reduce system quiescent currents. LPM can be entered only by sending the Enter Low-power mode command. All register settings programmed in Normal mode are maintained while in LPM.

The CD1030 exits LPM and enters Normal mode when any of the following events occur:

- Input switch change of state (when enabled)
- Interrupt timer expire
- Falling edge of WAKE_B (as set by the device configuration register)
- Falling edge of INT_B (with $V_{DDQ} = 5.0\text{ V}$)
- Falling edge of CS_B (with $V_{DDQ} = 5.0\text{ V}$)
- Power-ON Reset (POR)

The V_{DDQ} supply may be removed from the device during LPM, however removing V_{DDQ} from the device disables a wake-up from falling edge of INT_B and CS_B. The IC checks the status of V_{DDQ} after a falling edge of WAKE_B (as selected in the device configuration register), INT_B and CS_B. If V_{DDQ} is low, the IC returns to LPM and does not report a Wake event. If V_{DDQ} is high, the IC wakes up and reports the Wake event. In cases where CS_B is used to wake the device, the first MISO data message is not valid.

The LPM command contains settings for two programmable registers: the interrupt timer and the polling timer, as shown in [Table 30](#). The interrupt timer is used as a periodic wake-up timer. When the timer expires, an interrupt is generated and the device enters Normal mode. The polling timer is used periodically to poll the inputs during Low-power mode to check for change of states. The $t_{\text{ACTIVEPOLL}}$ time is the length of time the part is active during the polling timer to check for change of state. The polling pulse is set at 1.0 mA for SG channels and 2.0 mA for SB channels. If a switch closure is detected during the low-power mode, the CD1030 detects the change of state and starts providing the sustain current (2.0 mA) for about 416 μs until the device returns to the Normal mode (WAKE_B pulled low). Once in Normal mode, the input channel keeps supplying the sustain current (2.0 mA) for 270 μs more and then forces the corresponding wetting current. This mechanism protects against excessive inrush current, when the input capacitors discharge during the long polling cycles, and need to be recharged all at once upon waking up from the LPM.

The Low-power mode voltage threshold allows the user to determine the noise immunity versus lower current levels that polling allows. [Figure 16](#) shows the polling operation.

When polling and Interrupt timer coincide, the Interrupt timer wakes the device and the polling does not occur. When an input is determined to meet the Open condition (when entering LPM), yet while Open (on polling event), the chip does not continue the polling event for this input(s) to lower current in the chip.

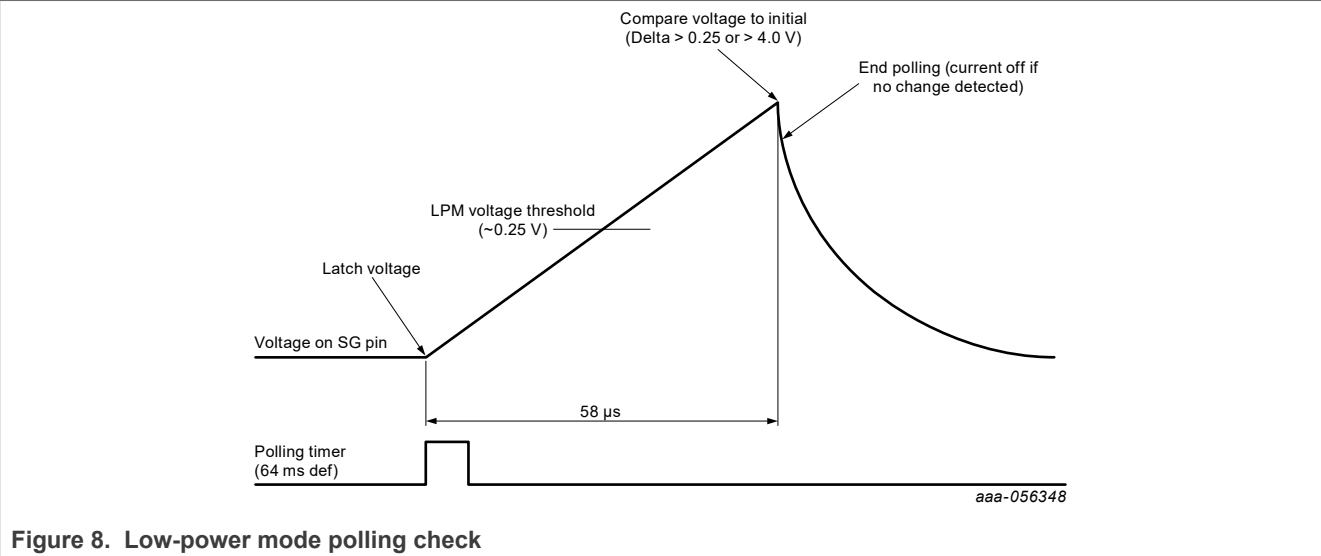


Figure 8. Low-power mode polling check

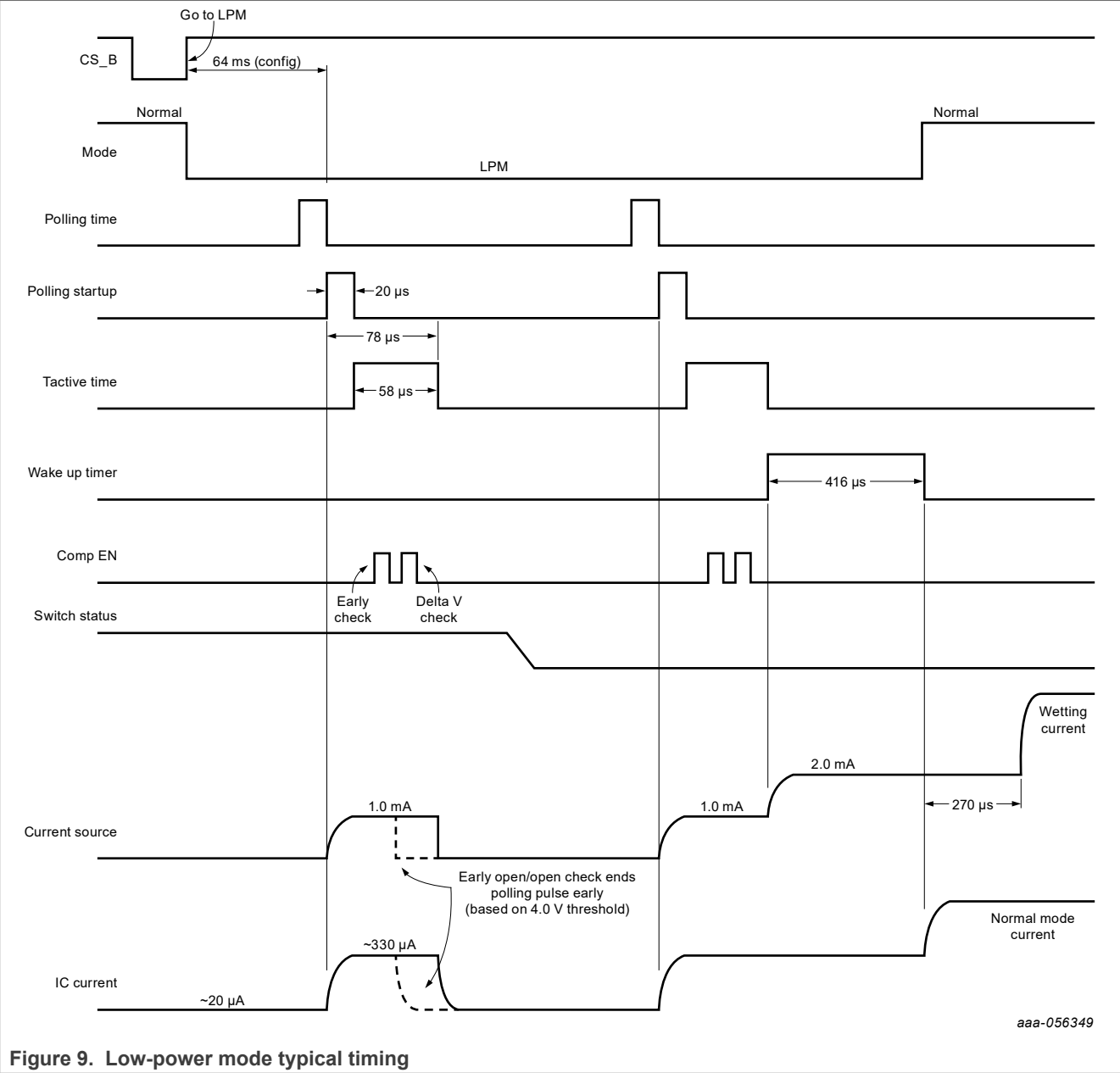


Figure 9. Low-power mode typical timing

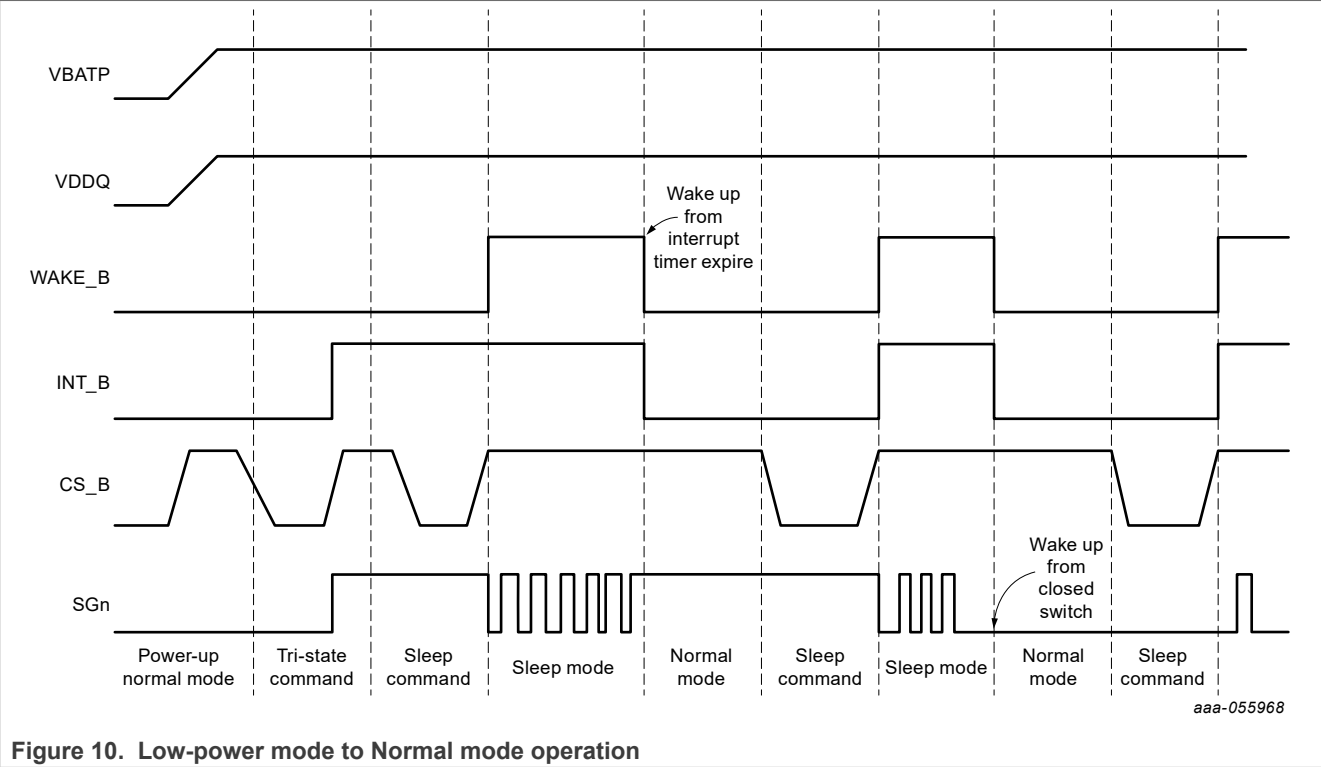


Figure 10. Low-power mode to Normal mode operation

8 Functional block description

8.1 State machine

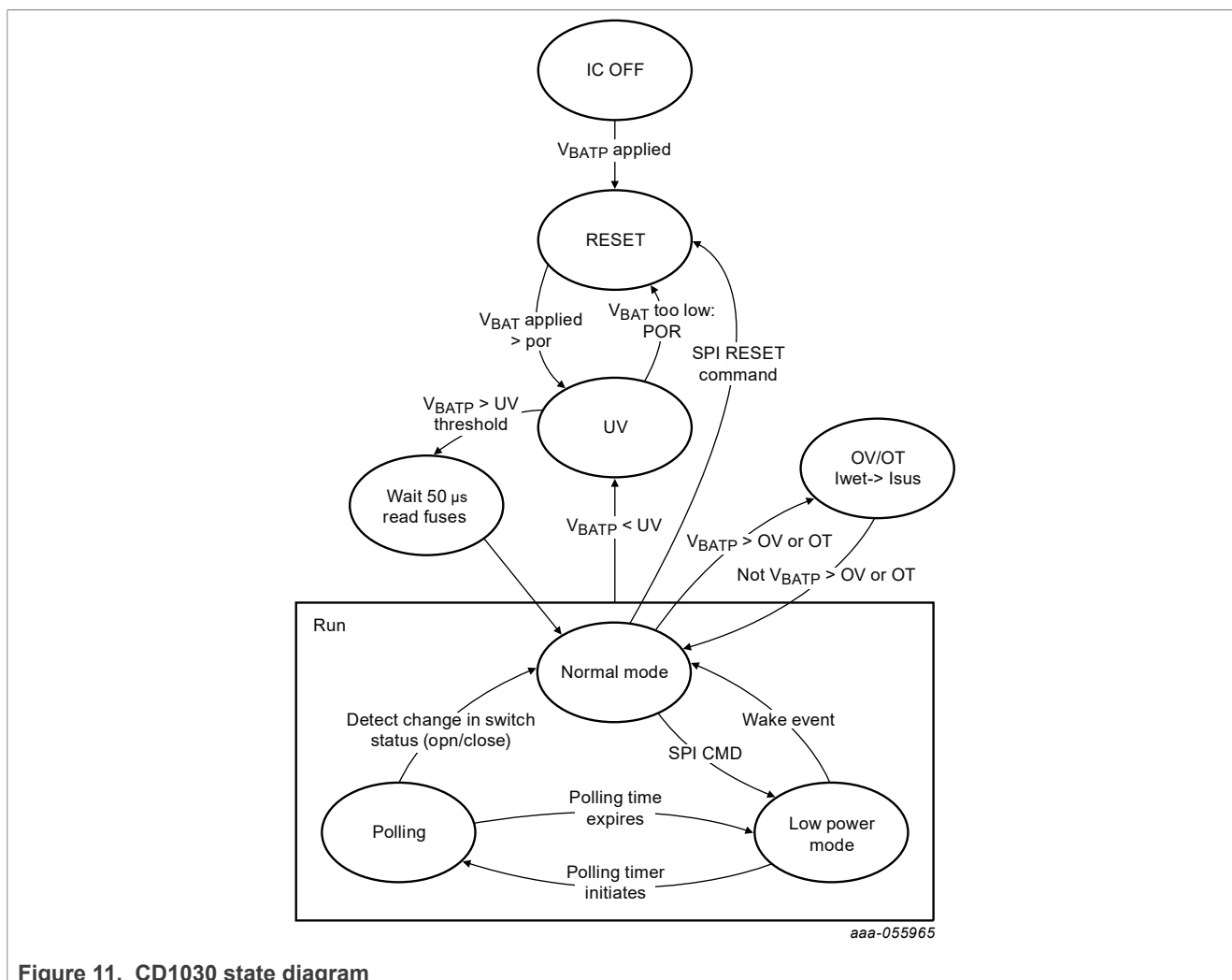


Figure 11. CD1030 state diagram

After power up, the IC enters into the device state machine, as illustrated in [Figure 18](#). The voltage on VBATP begins to power the internal oscillators and regulator supplies. The POR is based on the internal 2.5 V digital core rail. When the internal logic regulator reaches approximately 1.8 V (typically 3.3 V on the VBATP node), the IC enters into the UV range. Below the POR threshold, the IC is in RESET mode where no activity occurs.

8.1.1 UV: undervoltage lockout

After the POR circuit has reset the logic, the IC is in undervoltage. In this state, the IC remembers all register conditions, but is in a lockout mode, where no SPI communication is allowed. AMUX is inactive and the current sources are off. The user does not receive a valid response from the MISO, as it is disabled in this state. The chip oscillators (4.0 MHz for most normal mode activities, 192 kHz for LPM, and limited normal mode functions) are turned on in the UV state. The chip moves to the Read fuses state when the V_{BATP} voltage rises above the UV threshold (~4.3 V rising). The internal fuses read in approximately 50 μ s and the chip enters the Normal mode.

8.1.2 Normal mode

In Normal mode, the chip operates as selected in the available registers. Any command may be loaded in Normal mode, although not all (Low-power mode) registers are used in the Normal mode. All the LPM registers must be programmed in Normal mode, as the SPI is not active in LPM. The Normal mode of the chip is used to operate AMUX, communicate via the SPI, Interrupt the IC, wetting and sustain currents, as well as the thresholds available to use. The WAKE_B pin is asserted (low) in Normal mode and can be used to enable a power supply (ENABLE_B). Various fault detections are available in this mode including overvoltage, overtemperature, thermal warning, SPI errors, and Hash faults.

8.1.3 Low-power mode

When the user needs to lower the IC current consumption, a Low-power mode is used. The only method to enter LPM is through a SPI word. After the chip is in Low-power mode, the majority of circuitry is turned off including most power rails, the 4.0 MHz oscillator, and all the fault detection circuits. This mode is the lowest current consumption mode on the chip. If a fault occurs while the chip is in this mode, the chip does not see or register the fault (does not report via the SPI when awakened). Some items may wake the IC in this mode, including the interrupt timer, falling edge of INT_B, CS_B, or WAKE_B (configurable), or a comparator only mode switch detection.

8.1.4 Polling mode

The CD1030 uses a polling mode, which periodically (selectable in LPM config register) interrogates the input pins to determine in what state the pins are, and decide if there was a change of state from when the chip was in Normal mode. There are various configurations for this mode, allowing the user greater flexibility in operation. This mode uses the current sources to pull-up (SG) or down (SB) to determine if a switch is open or closed. More information is available on section [6.3, Low-power mode operation, page 24](#).

In the case of a low V_{BATP} , the polling pauses and waits until the V_{BATP} rises out of UV or a POR occurs. The pause of the polling ensures all of the internal rails, currents, and thresholds are up at the required levels to accurately detect open or closed switches. The chip does not wake-up in this condition and simply waits for the V_{BATP} voltage to rise or cause a POR.

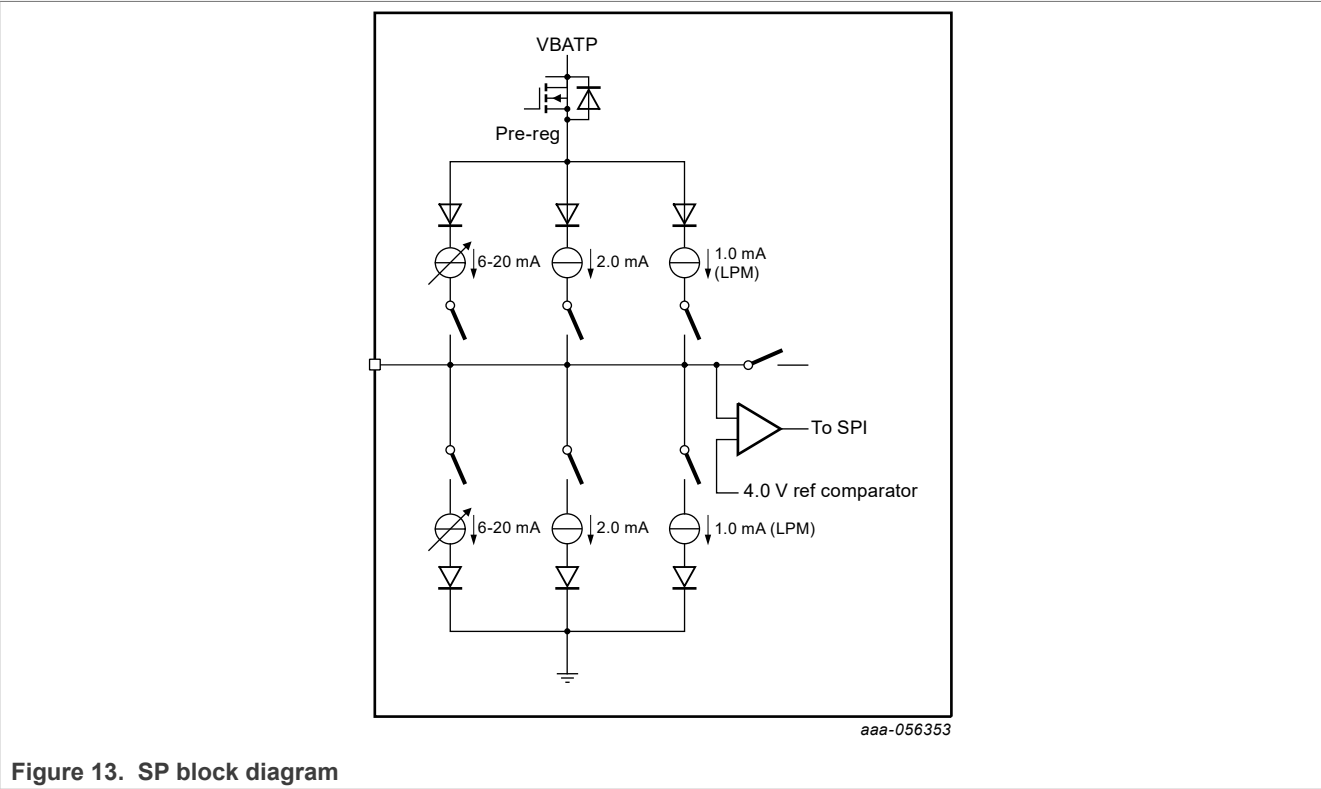
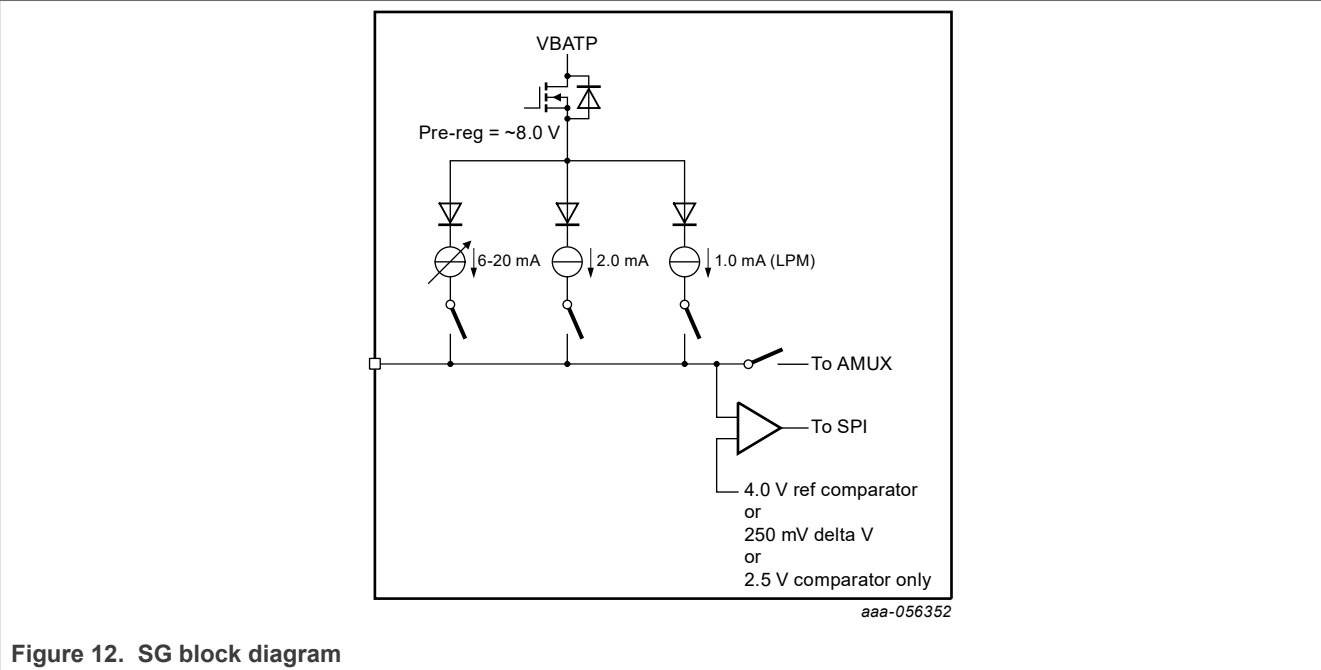
After the polling ends, the chip either returns to the Low-power mode, or enters Normal mode when a wake event was detected. Other events may wake the chip as well, such as the falling edge of CS_B, INT_B, or WAKE_B (configurable). A comparator only mode switch detection is always on in LPM or Polling mode, so a change of state for those inputs would effectively wake the IC in Polling mode as well.

If the wake-up enable bits are disabled on all channels (SG and SP), the device does not wake-up with a change of state on any of the input pins. In this case, the device disables the polling timer to allow the lowest current consumption during Low-power mode.

8.2 Input functional block

The SGx pins are switch-to-ground inputs only (pull-up current sources). The SPx pins are configurable as either switch to ground or switch to battery (pull-up current source or pull-down current sink). The input is compared with a 4.0 V (input comparator threshold) reference. Voltages greater than the input comparator threshold value are considered open for SG pins and closed for SB configuration. Voltages less than the input comparator threshold value are considered closed for SG pins and open for the SB configurations.

Programming features are defined in section [7.9, SPI control register definition, page 35](#) of this datasheet. The input comparator has hysteresis with the thresholds based on the closing of the switch (falling on SG, rising on SB). The user must take care to keep power conditions within acceptable limits (package is capable of 2.0 W). Using many of the inputs with continuous wetting current levels causes overheating of the IC and may cause an overtemperature (OT) event to occur.



8.3 Oscillator and timer control functional block

Two oscillators are generated in this block. A 4.0 MHz clock is used in Normal mode only, as well as a Low-power mode 192 kHz clock, which is on all the time. All timers are generated from these oscillators. The oscillator accuracy is 15% for both, the 4.0 MHz clock and the 192 kHz clock. No calibration is needed and the

accuracy is overvoltage and temperature. The timers in Low-power mode are generated from a base timer such that all timers coincide with other times. When polling and Interrupt timer coincide, the Interrupt timer wakes the device and the polling does not occur.

8.4 Temperature monitor and control functional block

The device has multiple thermal limit (t_{LIM}) cells to detect thermal excursions in excess of 155 °C. The t_{LIM} cells from various locations on the IC are logically ORed together and communicated to the MCU as one t_{LIM} fault. When the t_{LIM} value is detected, the wetting current is lowered to 2.0 mA until the temperature has decreased beyond the $t_{LIM(HYS)}$ value (the sustain current remains on or as selected). A hysteresis value of 15 °C exists to keep the device from cycling. A thermal flag also exists to alert the system to increasing temperature. The thermal flag is set at a typical value of 120 °C.

8.5 WAKE_B control functional block

The WAKE_B functions as an input (wake-up) or an output (open drain) pin. In Normal mode, the WAKE_B pin is low. In Low-power mode, the WAKE_B pin is pulled high. The WAKE_B pin has an internal pull-up to the V_{DDQ} supply, with an internal series diode to allow an external pull-up to V_{BATP} , if the specific application requires it.

As an input, with V_{DDQ} present, when the device is in Low-power mode and WAKE_B is pulled high (internally or externally), a falling edge of the WAKE_B pin brings the CD1030 into Normal mode. In Low-power mode, if V_{DDQ} goes low, the WAKE_B V_{DDQ} check bit in the [Device configuration register](#) can be used to ignore or allow a wake-up event upon a falling edge of the WAKE_B pin. Setting the WAKE_B V_{DDQ} check bit to 0, ignores the falling edge of WAKE_B when V_{DDQ} is low. Setting the WAKE_B V_{DDQ} check to 1, allows the WAKE_B falling edge to wake-up the device and go into Normal mode regardless of the status of V_{DDQ} . This allows the user to pull the WAKE_B pin up to V_{BATP} so it can be used in a setup in which V_{DDQ} is supposed to shut down during Low-power mode.

As an output, WAKE_B pin can drive either an MCU input or the EnableB of a regulator (possibly for V_{DDQ}). WAKE_B is driven LOW during Normal mode regardless of the state of V_{DDQ} . When the CD1030 is in LPM, the WAKE_B pin is released and is expected to be pulled up internally to V_{DDQ} or externally to V_{BATP} . When a valid wake-up event is detected, the CD1030 should wake-up from LPM and the WAKE_B should be driven LOW (regardless of the state of V_{DDQ}).

8.6 INT_B functional block

INT_B is an input/output pin in the CD1030 device to indicate an interrupt event has occurred, as well as receiving interrupts from other devices when the INT_B pins are wired ORed. The INT_B pin is an open-drain output with an internal pull-up to V_{DDQ} . In Normal mode, a switch state change triggers the INT_B pin (when enabled). The INT_B pin and INT_B bit in the SPI register are latched on the falling edge of CS_B, which permits the MCU to determine the origin of the interrupt. When two CD1030 devices are used, only the device initiating the interrupt has the INT_B bit set. The INT_B pin and INTflg bit are cleared 1.0 μ s after the falling edge of CS_B. The INT_B pin does not clear with the rising edge of CS_B if a switch contact change has occurred while CS_B was Low.

In a multiple CD1030 device system with WAKE_B high and V_{DDQ} in Low-power mode, the falling edge of INT_B places all CD1030s in Normal mode. The INT_B has the option of a pulsed output (pulsed low for INT_PULSE duration) or a latched low output. The default case is the latched low operation; the INT_B operation is selectable via the SPI. An INT_B request by the MCU can be done by a SPI word and results in an INT_PULSE of 100 μ s duration on the INT_B pin.

The chip causes an INT_B assertion for the following cases:

- 1. A change of state is detected
 - a. Interrupt timer expires
 - b. Any wake-up event
 - c. Any faults detected
 - d. After a POR, the INT_B pin is asserted during startup until the chip is ready to communicate

8.7 AMUX functional block

The analog voltage on switch inputs may be read by the MCU using the analog command ([Table 47](#)). Internal to the IC is a 35-to-1 analog multiplexer. The voltage present on the selected input pin is buffered and made available on the AMUX output pin. The output pin is clamped to a maximum of V_{DDQ} regardless of the higher voltages present on the input pin. After an input has been selected as the analog, the corresponding bit in the next MISO data stream is logic [0]. When selecting a channel to be read as analog input, the user can enable the current source to provide a current flow through the specific channel. Current level can be set to the programmed wetting current for the selected channel or set to high-impedance, as defined in [Table 46](#).

When selecting an input to be sent to the AMUX output, this input is not polled or wake-up from Low-power mode. The user should set AMUX to "No input selected" or "Temp diode" before entering Low-power mode. The AMUX pin is not active during Low-power mode. The SG5 pin can also be used as a VBATP sense pin. An internal resistor divider of 1/6 is provided for conditioning the V_{BATP} higher voltage to a level within the 0 V to V_{DDQ} range.

Along with the default SPI input selection method, the AMUX has two hardware operation such that the user can select an specific input channel by physically driving the SG1, SG2, or SG3 pin (HW 3-bit), or by driving the SG1 and SG2 pins (HW 2-bit), as shown in [Table 10](#) and [Table 11](#). When using the AMUX hardwired options, the SG1, SG2, and SG3 inputs use a 2.5 V input voltage threshold to read a logic 0 or logic 1. [Table 9](#) shows the AMUX selection methods configurable by the Aconfig0 and Aconfig1 bits in the [Device configuration](#) register.

Table 3. AMUX selection method

| Aconfig1 | Aconfig0 | AMUX selection method |
|----------|----------|-----------------------|
| 0 | 0 | SPI (def) |
| 0 | 1 | SPI |
| 1 | 0 | HW 2-bit |
| 1 | 1 | HW 3-bit |

Table 4. AMUX hardware 3-bit

| Pins [SG3, SG2, SG1] | Output of AMUX |
|----------------------|-------------------|
| 000 | SG0 |
| 001 | SG5 |
| 010 | SG6 |
| 011 | SG7 |
| 100 | SG8 |
| 101 | SG9 |
| 110 | Temperature Diode |
| 111 | Battery Sense |

Table 5. AMUX hardware 2-bit

| Pins [SG2, SG1] | Output of AMUX |
|-----------------|----------------|
| 00 | SG0 |
| 01 | SG5 |
| 10 | SG6 |
| 11 | SG7 |

Since the device is required to meet the ± 1.0 V offset with ground, it is imperative the user bring the sensor ground back to the CD1030 when using AMUX for accurate measurements, to ensure any ground difference does not impact the device operation.

8.8 Serial peripheral interface (SPI)

The CD1030 contains a serial peripheral interface consisting of Serial Clock (SCLK), Serial Data Out (MISO), Serial Data In (MOSI), and Chip Select Bar (CS_B). The SPI interface is used to provide configuration, control, and status functions. The user may read the registers contents as well as read some status bits of the IC. The CD1030 is configured as a SPI secondary device.

All SPI transmissions to the CD1030 must be done in exact increments of 32 bits (modulo 0 is ignored as well). The CD1030 contains a data valid method via SCLK input to keep non-modulo 32-bit transmissions from being written into the IC. The SPI module also provides a daisy chain capability to accommodate MOSI to MISO wrap around (see [Figure 24](#)). The SPI registers have a hashing technique to ensure the registers are consistent with the programmed values. If the hashed value does not match the register status, a SPI bit is set, as well as an interrupt to alert the MCU to this issue.

8.8.1 Chip select low (CS_B)

The CS_B input selects this device for serial transfers. On the falling edge of CS_B, the MISO pin is released from tri-state mode, and all status information are latched in the SPI shift register. While CS_B is asserted, register data is shifted in the MOSI pin and shifted out the MISO pin on each subsequent SCLK. On the rising edge of CS_B, the MISO pin is tri-stated and the fault register reloaded (latched) with the current filtered status data. To allow sufficient time to reload the fault registers, the CS_B pin must remain low for a minimum of t_{CSN} prior to going high again.

The CS_B input contains a pull-up current source to VDDQ to command the de-asserted state should an open-circuit condition occur. This pin has threshold compatible voltages allowing proper operation with microprocessors using a 3.3 V to 5.0 V supply.

8.8.2 Serial clock (SCLK)

The SCLK input is the clock signal input for synchronization of serial data transfer. This pin has a threshold compatible voltage allowing proper operation with microprocessors using a 3.3 V to 5.0 V supply.

When CS_B is asserted, both the Primary Microprocessor and the CD1030 latch input data on the rising edge of SCLK. The SPI primary device typically shifts data out on the falling edge of SCLK. The CD1030 shifts data out on the falling edge of SCLK as well, to allow more time to drive the MISO pin to the proper level.

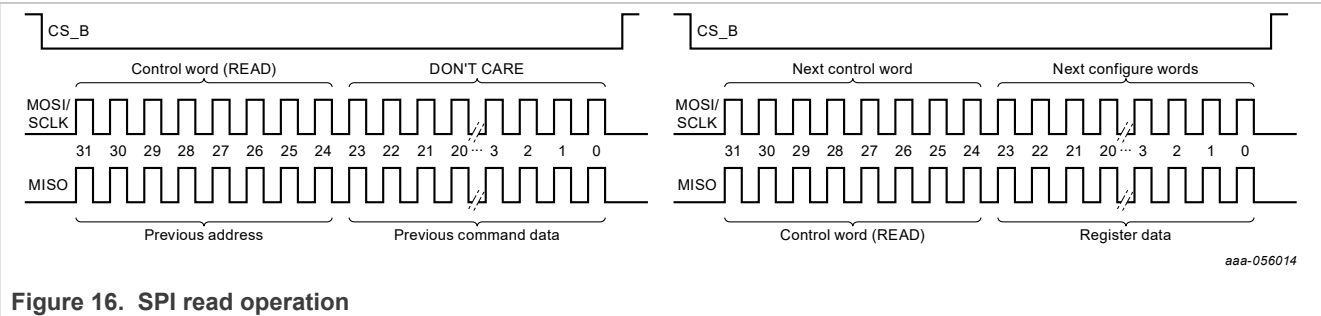
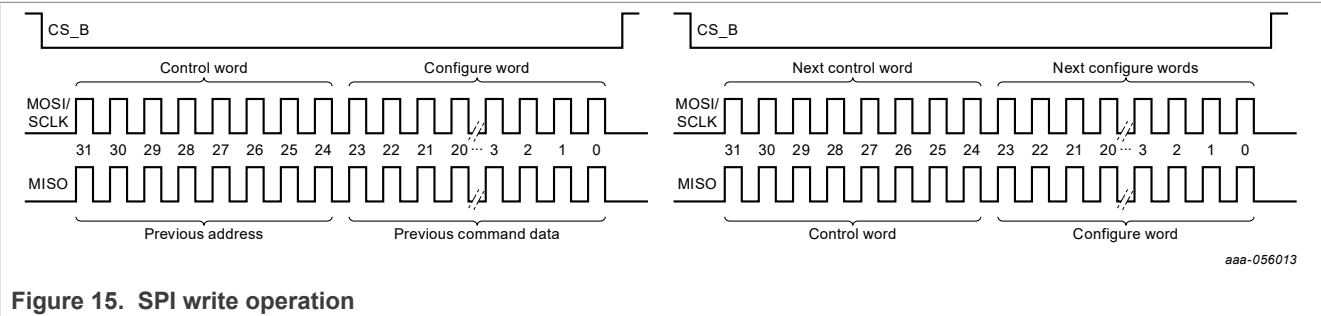
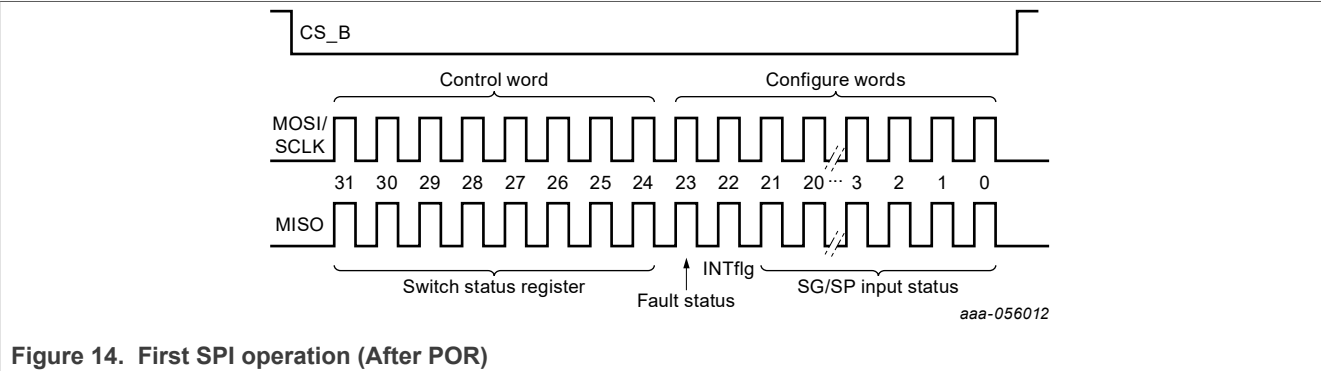
This input is used as the input for the modulo 32-bit counter validation. Any SPI transmissions which are NOT exact multiples of 32 bits (clock edges) are treated as illegal transmissions. The entire frame is aborted and no information is changed in the configuration or control registers.

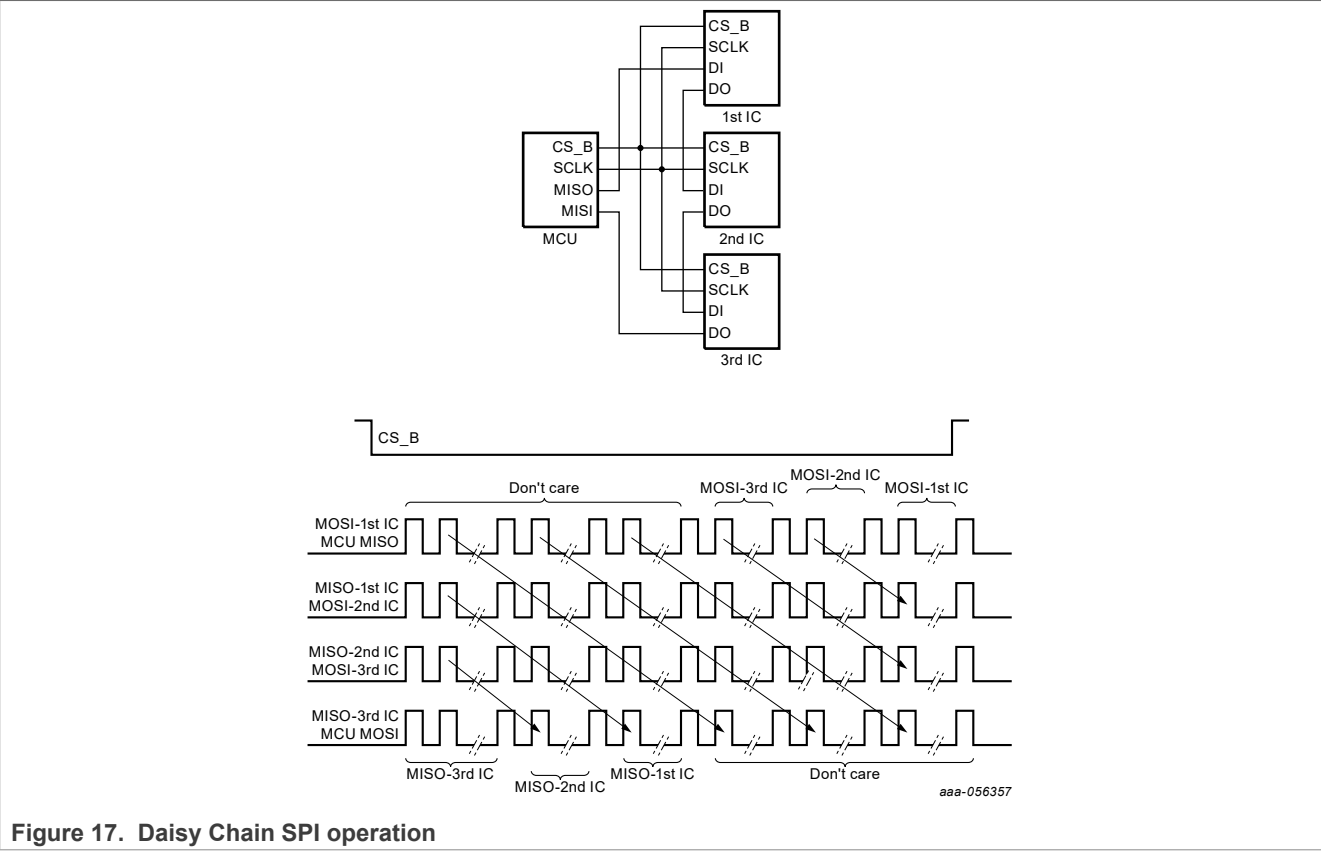
8.8.3 Serial data output (MISO)

The MISO output pin is in a tri-state condition when CS_B is negated. When CS_B is asserted, MISO is driven to the state of the MSB of the internal register and starts shifting out the requested data from the MSB to the LSB. This pin supplies a "rail to rail" output, depending on the voltage at the VDDQ pin.

8.8.4 Serial data input (MOSI)

The MOSI input takes data from the primary microprocessor while CS_B is asserted. The MSB is the first bit of each word received on MOSI and the LSB is the last bit of each word received on MOSI. This pin has threshold level compatible input voltages allowing proper operation with microprocessors using a 3.3 V to 5.0 V (V_{DDQ}) supply.





8.9 SPI control register definition

A 32-bit SPI allows the system microprocessor to configure the CD1030 for each input as well as read out the status of each input. The SPI also allows the Fault Status and INTflg bits to be read via the SPI. The SPI MOSI bit definitions are given in [Table 12](#):

Table 6. MOSI input register bit definition

| Register # | Register name | Address | | | | | | | Rb/W |
|------------|--|---------|---|---|---|---|---|---|------|
| 0 | SPI check | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| 02/03 | Device configuration register | 0 | 0 | 0 | 0 | 0 | 0 | 1 | 0/1 |
| 04/05 | Tri-state SP register | 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0/1 |
| 06/07 | Tri-state SG register | 0 | 0 | 0 | 0 | 0 | 1 | 1 | 0/1 |
| 08/09 | Wetting current level SP register 0 | 0 | 0 | 0 | 0 | 1 | 0 | 0 | 0/1 |
| 0A/0B | Wetting current level SG register 0 | 0 | 0 | 0 | 0 | 1 | 0 | 1 | 0/1 |
| 0C/0D | Wetting current level SG register 1 | 0 | 0 | 0 | 0 | 1 | 1 | 0 | 0/1 |
| 0E/0F | Wetting current level SG register 2 | 0 | 0 | 0 | 0 | 1 | 1 | 1 | 0/1 |
| 10/11 | Wetting current level SP register 1 | 0 | 0 | 0 | 1 | 0 | 0 | 0 | 0/1 |
| 16/17 | Continuous wetting current SP register | 0 | 0 | 0 | 1 | 0 | 1 | 1 | 0/1 |
| 18/19 | Continuous wetting current SG register | 0 | 0 | 0 | 1 | 1 | 0 | 0 | 0/1 |
| 1A/1B | Interrupt enable SP register | 0 | 0 | 0 | 1 | 1 | 0 | 1 | 0/1 |
| 1C/1D | Interrupt enable SG register | 0 | 0 | 0 | 1 | 1 | 1 | 0 | 0/1 |
| 1E/1F | Low-power mode configuration | 0 | 0 | 0 | 1 | 1 | 1 | 1 | 0/1 |
| 20/21 | Wake-up enable register SP | 0 | 0 | 1 | 0 | 0 | 0 | 0 | 0/1 |
| 22/23 | Wake-up enable register SG | 0 | 0 | 1 | 0 | 0 | 0 | 1 | 0/1 |
| 24/25 | Comparator only SP | 0 | 0 | 1 | 0 | 0 | 1 | 0 | 0/1 |
| 26/27 | Comparator only SG | 0 | 0 | 1 | 0 | 0 | 1 | 1 | 0/1 |
| 28/29 | LPM voltage threshold SP configuration | 0 | 0 | 1 | 0 | 1 | 0 | 0 | 0/1 |
| 2A/2B | LPM voltage threshold SG configuration | 0 | 0 | 1 | 0 | 1 | 0 | 1 | 0/1 |
| 2C/2D | Polling current SP configuration | 0 | 0 | 1 | 0 | 1 | 1 | 0 | 0/1 |
| 2E/2F | Polling current SG configuration | 0 | 0 | 1 | 0 | 1 | 1 | 1 | 0/1 |

Table 6. MOSI input register bit definition...continued

| Register # | Register name | Address | | | | | | | Rb/W |
|------------|---|---------|---|---|---|---|---|---|------|
| 30/31 | Slow polling SP | 0 | 0 | 1 | 1 | 0 | 0 | 0 | 0/1 |
| 32/33 | Slow polling SG | 0 | 0 | 1 | 1 | 0 | 0 | 1 | 0/1 |
| 34/35 | Wake-up debounce SP | 0 | 0 | 1 | 1 | 0 | 1 | 0 | 0/1 |
| 36/37 | Wake-up debounce SG | 0 | 0 | 1 | 1 | 0 | 1 | 1 | 0/1 |
| 39 | Enter Low-power mode | 0 | 0 | 1 | 1 | 1 | 0 | 0 | 1 |
| 3A/3B | AMUX control register | 0 | 0 | 1 | 1 | 1 | 0 | 1 | 0/1 |
| 3C | Read switch status registers SP | 0 | 0 | 1 | 1 | 1 | 1 | 0 | 0 |
| 3E | Read switch status registers SG | 0 | 0 | 1 | 1 | 1 | 1 | 1 | 0 |
| 42 | Fault status register | 0 | 1 | 0 | 0 | 0 | 0 | 1 | 0 |
| 47 | Interrupt request | 0 | 1 | 0 | 0 | 0 | 1 | 1 | 1 |
| 49 | Reset register | 0 | 1 | 0 | 0 | 1 | 0 | 0 | 1 |

The 32-bit SPI word consists of a command word (8-bit) and three configure words (24-bit). The 8 MSB bits are the command bits that select what type of configuration is to occur. The remaining 24-bits are used to select the inputs to be configured.

- Bit 31 - 24 = Command word: Use to select what configuration is to occur (example: setting wake-up enable command)
- Bit 23 - 0 = SGn input select word: Use these bits in conjunction with the command word to determine which input is setup.

Configuration registers may be read or written to. To read the contents of a configuration register, send the register address + '0' on the LSB of the command word; the contents of the corresponding register is shifted out of the MISO buffer in the next SPI cycle. When a Read command is sent, the answer (in the next SPI transaction) includes the Register address in the upper byte (see [Figure 23](#)).

Read example:

- Send 0x0C00_0000 Receive: 8000_0000 (for example after a POR)
- Send 0x0000_0000 Receive: 0C00_0000 (address + register data)

The first response from the device after a POR event is a Read Status register (0x3Exxxxxx where x is the status of the inputs). This is the same for exiting the Low-power mode (see [Figure 21](#)).

To write into a configuration register, send the register Address + '1' on the LSB of the command word and the configuration data on the next 24 bits. The new value of the register is shifted out of the MISO buffer in the next SPI cycle, along with the register address and the corresponding read or write bit.

The fault/status diagnostic capability consists of two Switch Status registers and one Fault status register (shown in [Table 13](#)).

33-channel multiple switch detection interface with programmable wetting current

Table 7. Switch status and Fault registers

| Commands | [31-25] Address | 24 R | 23 | 22 | 21 | 20 | 19 | 18 | 17 | 16 | 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|-----------------------|--------------------|---------|--------------|--------|----|------|------|------|------|------|------|------|------|------|------|-----------|------------|-----|-----|-----|----------|-----|------------|--------|---------|-----|
| Read Switch Status SP | 0011110 | 0 | FAULT STATUS | INTflg | X | X | X | X | X | X | X | X | X | X | SP11 | SP10 | SP9 | SP8 | SP7 | SP6 | SP5 | SP4 | SP3 | SP2 | SP1 | SP0 |
| Read Switch Status SG | 0011111 | 0 | FAULT STATUS | INTflg | X | SG20 | SG19 | SG18 | SG17 | SG16 | SG15 | SG14 | SG13 | SG12 | SG11 | SG10 | SG9 | SG8 | SG7 | SG6 | SG5 | SG4 | SG3 | SG2 | SG1 | SG0 |
| Fault Status | 0100001 | 0 | X | INTflg | X | X | X | X | X | X | X | X | X | X | X | SPI Error | hash fault | X | UV | OV | TempFlag | OT | INT_B wake | WAKE_B | SpiWake | POR |

In the Read Status Register SP, Bits 0 – 11 shows the status of each one of the SP inputs, where logic [1] is a closed switch and logic [0] is an open switch. In addition to input status information, Fault conditions and interrupts are reported through bits FAULT STATUS [23] and INTflg [22].

In the Read Status Register SG, Bits 0 - 20 show the status of each one of the SG input, where logic [1] is a closed switch and logic [0] is an open switch. In addition to input status information, fault conditions and interrupts are reported through bits FAULT STATUS [23] and INTflg [22].

The Fault Status Register latches the respective bit high when a specific fault event occurs. All possible fault events are described in [Table 50](#). When a Fault Status command is sent, a SPI read cycle is initiated by a CS_B falling edge, followed by 32 SCLK cycles to shift the fault status register out the MISO pin. The INTflg bit is cleared 1.0 ms after the falling edge of CSB.

On most registers where the first two significant bits are available, bit 23 is an OR of all the fault status register bits and bit 22 is latched high following any interrupt event. Registers which have all bits dedicated for other purposes, such as the Wetting Current Level or the SPI check registers, do not have these interrupt or fault status bits.

When a register with a int flag (bit-22) set high is read, the INTflg bit is globally cleared. For the case of bit-23 high, it is cleared after the Fault Status Register is read, and the respective fault flag is cleared.

The Fault status bit sets any time a fault occurs. A read of the fault status register must be done to clear the Fault status bit. The fault bit immediately sets again if the fault condition is still present. The INTflg bit sets any time an interrupt event occurs (change of state on switch, or any fault status bit gets set). Any SPI command that returns INTflg bit clears this flag, even if the event is still occurring, for example, an overtemp causes an interrupt. The interrupt can be cleared but the chip does not interrupt again based on the overtemp until the Overtemp flag has been cleared. A thermal fault latches as soon as it occurs.

[Table 14](#) provides a general overview of the functional SPI commands and configuration bits.

Table 8. Functional SPI register

| Commands | [31-25] Address | 24 R/W | 23 ⁽²⁶⁾ | 22 ⁽²⁶⁾ | 21 | 20 | 19 | 18 | 17 | 16 | 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|----------------------------|--------------------|-----------|--------------------|--------------------|----|----------|------|------|----------------|------------------------|-------------------|--------------|----------|----------|----------|------|-----|----------|-----|-----|----------|-----|-----|----------|-----|-----|
| SPI check | 0000000 | 0 | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X |
| Device Configuration | 0000001 | 0/1 | X | X | X | X | X | X | SBPOLL TIME | VBATP OV Disable | WAKE_B Pull up | IntB_ Out | aconfig1 | aconfig0 | SP11 | SP10 | SP9 | SP8 | SP7 | SP6 | SP5 | SP4 | SP3 | SP2 | SP1 | SP0 |
| Tri-state Enable SP | 0000010 | 0/1 | X | X | X | X | X | X | X | X | X | X | X | X | SP11 | SP10 | SP9 | SP8 | SP7 | SP6 | SP5 | SP4 | SP3 | SP2 | SP1 | SP0 |
| Tri-state Enable SG | 0000011 | 0/1 | X | X | X | SG20 | SG19 | SG18 | SG17 | SG16 | SG15 | SG14 | SG13 | SG12 | SG11 | SG10 | SG9 | SG8 | SG7 | SG6 | SG5 | SG4 | SG3 | SG2 | SG1 | SG0 |
| Wetting Current Level SP 0 | 0000100 | 0/1 | SP7[2-0] | | | SP6[2-0] | | | SP5[2-0] | | | SP4[2-0] | | | SP3[2-0] | | | SP2[2-0] | | | SP1[2-0] | | | SP0[2-0] | | |

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Table 8. Functional SPI register...continued

| Commands | [31-25] Address | 24 R/W | 23 ⁽²⁶⁾ | 22 ⁽²⁶⁾ | 21 | 20 | 19 | 18 | 17 | 16 | 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
|--------------------------------|--------------------|-----------|--------------------|--------------------|----|-----------|------|------|-----------|------|------|-----------|------|------|-----------|------|-----|-----------|------|-------|-----------|-------|-------|-----------|-------|-------|
| Wetting Current Level SG 0 | 0000101 | 0/1 | SG7[2-0] | | | SG6[2-0] | | | SG5[2-0] | | | SG4[2-0] | | | SG3[2-0] | | | SG2[2-0] | | | SG1[2-0] | | | SG0[2-0] | | |
| Wetting Current Level SG 1 | 0000110 | 0/1 | SG15[2-0] | | | SG14[2-0] | | | SG13[2-0] | | | SG12[2-0] | | | SG11[2-0] | | | SG10[2-0] | | | SG9[2-0] | | | SG8[2-0] | | |
| Wetting Current Level SG 2 | 0000111 | 0/1 | X | X | X | X | X | X | X | X | X | SG20[2-0] | | | SG19[2-0] | | | SG18[2-0] | | | SG17[2-0] | | | SG16[2-0] | | |
| Wetting Current Level SP 1 | 0001000 | 0/1 | X | X | X | X | X | X | X | X | X | X | X | X | SP11[2-0] | | | SP10[2-0] | | | SP9[2-0] | | | SP8[2-0] | | |
| Cont Wetting Current Enable SP | 0001011 | 0/1 | X | X | X | X | X | X | X | X | X | X | X | X | SP11 | SP10 | SP9 | SP8 | SP7 | SP6 | SP5 | SP4 | SP3 | SP2 | SP1 | SP0 |
| Cont Wetting Current Enable SG | 0001100 | 0/1 | X | X | X | SG20 | SG19 | SG18 | SG17 | SG16 | SG15 | SG14 | SG13 | SG12 | SG11 | SG10 | SG9 | SG8 | SG7 | SG6 | SG5 | SG4 | SG3 | SG2 | SG1 | SG0 |
| Interrupt Enable SP | 0001101 | 0/1 | X | X | X | X | X | X | X | X | X | X | X | X | SP11 | SP10 | SP9 | SP8 | SP7 | SP6 | SP5 | SP4 | SP3 | SP2 | SP1 | SP0 |
| Interrupt Enable SG | 0001110 | 0/1 | X | X | X | SG20 | SG19 | SG18 | SG17 | SG16 | SG15 | SG14 | SG13 | SG12 | SG11 | SG10 | SG9 | SG8 | SG7 | SG6 | SG5 | SG4 | SG3 | SG2 | SG1 | SG0 |
| Low-power Mode configuration | 0001111 | 0/1 | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | int3 | int2 | int2 | int0 | poll3 | poll2 | poll1 | poll0 |
| Wake-up Enable SP | 0010000 | 0/1 | X | X | X | X | X | X | X | X | X | X | X | X | SP11 | SP10 | SP9 | SP8 | SP7 | SP6 | SP5 | SP4 | SP3 | SP2 | SP1 | SP0 |
| Wake-up Enable SG | 0010001 | 0/1 | X | X | X | SG20 | SG19 | SG18 | SG17 | SG16 | SG15 | SG14 | SG13 | SG12 | SG11 | SG10 | SG9 | SG8 | SG7 | SG6 | SG5 | SG4 | SG3 | SG2 | SG1 | SG0 |
| LPM Comparator Only SP | 0010010 | 0/1 | X | X | X | X | X | X | X | X | X | X | X | X | SP11 | SP10 | SP9 | SP8 | SP7 | SP6 | SP5 | SP4 | SP3 | SP2 | SP1 | SP0 |
| LPM Comparator Only SG | 0010011 | 0/1 | X | X | X | SG20 | SG19 | SG18 | SG17 | SG16 | SG15 | SG14 | SG13 | SG12 | SG11 | SG10 | SG9 | SG8 | SG7 | SG6 | SG5 | SG4 | SG3 | SG2 | SG1 | SG0 |
| LPM Voltage Threshold SP | 0010100 | 0/1 | X | X | X | X | X | X | X | X | X | X | X | X | SP11 | SP10 | SP9 | SP8 | SP7 | SP6 | SP5 | SP4 | SP3 | SP2 | SP1 | SP0 |
| LPM Voltage Threshold SG | 0010101 | 0/1 | X | X | X | SG20 | SG19 | SG18 | SG17 | SG16 | SG15 | SG14 | SG13 | SG12 | SG11 | SG10 | SG9 | SG8 | SG7 | SG6 | SG5 | SG4 | SG3 | SG2 | SG1 | SG0 |
| LPM Polling current config SP | 0010110 | 0/1 | X | X | X | X | X | X | X | X | X | X | X | X | SP11 | SP10 | SP9 | SP8 | SP7 | SP6 | SP5 | SP4 | SP3 | SP2 | SP1 | SP0 |
| LPM Polling current config SG | 0010111 | 0/1 | X | X | X | SG20 | SG19 | SG18 | SG17 | SG16 | SG15 | SG14 | SG13 | SG12 | SG11 | SG10 | SG9 | SG8 | SG7 | SG6 | SG5 | SG4 | SG3 | SG2 | SG1 | SG0 |
| LPM Slow Polling SP | 0011000 | 0/1 | X | X | X | X | X | X | X | X | X | X | X | X | SP11 | SP10 | SP9 | SP8 | SP7 | SP6 | SP5 | SP4 | SP3 | SP2 | SP1 | SP0 |
| LPM Slow Polling SG | 0011001 | 0/1 | X | X | X | SG20 | SG19 | SG18 | SG17 | SG16 | SG15 | SG14 | SG13 | SG12 | SG11 | SG10 | SG9 | SG8 | SG7 | SG6 | SG5 | SG4 | SG3 | SG2 | SG1 | SG0 |
| Wake-up Debounce SP | 0011010 | 0/1 | X | X | X | X | X | X | X | X | X | X | X | X | SP11 | SP10 | SP9 | SP8 | SP7 | SP6 | SP5 | SP4 | SP3 | SP2 | SP1 | SP0 |
| Wake-up Debounce SG | 0011011 | 0/1 | X | X | X | SG20 | SG19 | SG18 | SG17 | SG16 | SG15 | SG14 | SG13 | SG12 | SG11 | SG10 | SG9 | SG8 | SG7 | SG6 | SG5 | SG4 | SG3 | SG2 | SG1 | SG0 |
| Enter Low-power Mode | 0011100 | 1 | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X |
| AMUX Channel Select SPI | 0011101 | 0/1 | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | asett | asel5 | asel4 | asel3 | asel2 | asel1 | asel0 |
| Read Switch Status SP | 0011110 | 0 | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X |
| Read Switch Status SG | 0011111 | 0 | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X |
| Fault Status | 0100001 | 0 | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X |
| Interrupt Pulse Request | 0100011 | 1 | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X |
| Reset | 0100100 | 1 | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X | X |

26. Bits 23 and 22 are used for FAULT STATUS and INTflg global diagnostic flags (Read only) respectively. INTflg is cleared out upon reading of any register with this flag available. The FAULT STATUS flag is cleared upon reading the fault status register and no fault event present anymore.

8.9.1 SPI check

The MCU may check the communication with the IC by using the SPI Check register. The MCU sends the command and the response during the next SPI transaction is 0x123456. The SPI Check command does not return Fault Status or INTflg bit, therefore this bit is not cleared upon a SPI check command.

Table 9. SPI check command

| Register address | R | SPI data bits [23 - 0] |
|------------------|----|------------------------|
| [31-25] | 24 | bits [23 - 16] |
| 0000_000 | 0 | 0000_0000 |
| | | bits [15 - 8] |
| | | 0000_0000 |
| | | bits [7 - 0] |
| | | 0000_0000 |
| MISO Return Word | | 0x00123456 |

8.9.2 Device configuration register

The device has various configuration settings that are global in nature. The configuration settings are as follows:

- When the SP channels are programmed to detect a Switch to Battery (SB), the SBPOLLTIME bit can be used to program the length of the polling pulse during the Low-power mode operation. A logic [0] sets the active polling timer to 1.2 ms and a logic [1] sets the active polling timer to 58 us.
- When the CD1030 is in the overvoltage region, a Logic [0] on the VBATP OV bit, limits the wetting current on all input channels to 2.0 mA, and the CD1030 is not able to enter into the Low-power mode. A Logic [1] allows the device to operate normally even on the overvoltage region. The OV flag sets when the device enters in the OV region, regardless the value of the VBATP OV bit.
- WAKE_B can be used to enable an external power supply regulator to supply the V_{DDQ} voltage rail. When the WAKE_B V_{DDQ} check bit is a Logic [0], the WAKE_B pin is expected to be pulled-up internally or externally to V_{DDQ}, and V_{DDQ} is expected to go low, and so the CD1030 does not wake-up on the falling edge of WAKE_B. A Logic [1], assumes the user uses an external pull-up to V_{BATP} or V_{DDQ} (when V_{DDQ} is not expected to be off) and the IC wakes up on a falling edge of WAKE_B.
- INT_B out is used to select how the INT_B pin operates when an interrupt occurs. The IC is able to pulse low [1] or latch low [0].
- A config[1-0] is used to determine the method of selecting the AMUX output, either a SPI command or using a hardwired setup with SG[3-1].
- SP0-7 inputs may be programmable for switch-to-battery or switch-to-ground. To set a SPx input for switch-to-battery, a logic [1] for the appropriate bit must be set. To set a SPx input for switch-to-ground, a logic [0] for the appropriate bit must be set. The MCU may change or update the programmable switch register via software at any time in Normal mode. Regardless of the setting, when the SPx input switch is closed, a logic [1] is placed in the serial output response register. If an SP is changed from SB or SG, the chip generates an interrupt, since the SPI registers for the switch status change due to the change of polarity of SB / SG.

Table 10. Device configuration register

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|--------|--------|--------|--------|-------------|------------------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0000_001 | 0/1 | FAULT STATUS | INTflg | Unused | | | | SBPOLL TIME | VBATP OV disable |

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Table 10. Device configuration register...continued

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|-----------|---------------|----------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| Default on POR | | X | X | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit 11 | bit 10 | bit 9 | bit 8 |
| | | WAKE_B VDDQ Check | INT_B out | Aconfig1 | Aconfig0 | SP11 | SP10 | SP9 | SP8 |
| | | 1 | 0 | 0 | 0 | 1 | 1 | 1 | 1 |
| | | bit 7 | bit 6 | bit 5 | bit 4 | bit 3 | bit 2 | bit 1 | bit 0 |
| | | SP7 | SP6 | SP5 | SP4 | SP3 | SP2 | SP1 | SP0 |
| | | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 |
| MISO Return Word | | bit 23 | bit 22 | bits [21 - 0] | | | | | |
| 0000_001[R/W] | | FAULT STATUS | INTflg | Register Data | | | | | |

Table 11. Device configuration bits definition

| Bit | Functions | Default value | Description |
|-------|-------------------|---------------|---|
| 23 | FAULT STATUS | X | The FAULT STATUS flag is a read only bit. It is set when a fault occurs and it is cleared upon reading the fault status register with no fault event is present anymore. It is a global variable and clearing the flag once clears it for all registers. |
| 22 | INTflg | X | The INTflg is a read only bit. It is set when an interrupt event occurs and it is cleared upon a read/write transaction of a register containing the INTflg. It is a global variable and clearing the flag once clears it for all registers. |
| 21-18 | Unused | 0 | Unused |
| 17 | SBPOLLTIME | 0 | Select the polling time for SP channels configured as SB. <ul style="list-style-type: none">• A logic [0] set the active polling timer to 1.0 ms,• A logic [1] sets the active polling timer to 55 μs. |
| 16 | VBATP OV Disable | 0 | VBATP Overvoltage protection <ul style="list-style-type: none">• 0 - Enabled• 1 - Disable |
| 15 | WAKE_B VDDQ Check | 1 | Enable/Disable WAKE_B to wake-up the device on falling edge when V _{DDQ} is not present. <ul style="list-style-type: none">• 0 - WAKE_B is pulled up to V_{DDQ} (internally and/or externally). WAKE_B is ignored while in LPM if V_{DDQ} is low.• 1 - WAKE_B is externally pulled up to V_{BATP} or V_{DDQ} and wakes upon a falling edge of the WAKE_B pin regardless of the V_{DDQ} status.(V_{DDQ} is not expected to go low) |
| 14 | Int_B_Out | 0 | Interrupt pin behavior <ul style="list-style-type: none">• 0 - INT pin stays low when interrupt occurs• 1 - INT pin pulse low and return high |
| 13-12 | Aconfig(1-0) | 00 | Configure the AMUX output control method <ul style="list-style-type: none">• 00 - SPI (default)• 01 - SPI• 10 - HW 2-bit• 11 - HW 3-bit Refer to section 7.7, AMUX functional block, page 31 for details on 2 and 3-bit hardwire configuration. |
| 11-0 | SP11 - SP0 | 111_1111_1111 | Configure the SP pin as Switch to Battery (SB) or Switch to ground (SG) <ul style="list-style-type: none">• 0 - Switch to Ground• 1 - Switch to Battery |

8.9.3 Tri-state SP register

The tri-state command is used to set the input nodes as high-impedance ([Table 18](#)). By setting the tri-state register bit to logic [1], the input is high-impedance regardless of the wetting current setting. The configurable comparator (4.0 V default) on each input remains active. The MCU may change or update the tri-state register via software at any time in Normal mode. The tri-state register defaults to 1 (inputs are tri-stated). Any input in tristate mode is still polled in LPM but the current source is not active during this time. The determination of change of state occurs at the end of the $t_{ACTIVEPOLL}$ and the wake-up decision is made.

Table 12. Tri-state SP register

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|---------------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0000_010 | 0/1 | FAULT STATUS | INTflg | Unused | | | | | |
| Default on POR | | X | X | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit 11 | bit 10 | bit 9 | bit 8 |
| | | Unused | | | | SP11 | SP10 | SP9 | SP8 |
| | | 0 | 0 | 0 | 0 | 1 | 1 | 1 | 1 |
| | | bit 7 | bit 6 | bit 5 | bit 4 | bit 3 | bit 2 | bit 1 | bit 0 |
| | | SP7 | SP6 | SP5 | SP4 | SP3 | SP2 | SP1 | SP0 |
| | | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 |
| MISO Return Word | | bit 23 | bit 22 | bits [21 - 0] | | | | | |
| 0000_010[R/W] | | FAULT STATUS | INTflg | Register Data | | | | | |

8.9.4 Tri-state SG register

The tri-state command is used to set the input nodes as high-impedance ([Table 19](#)). By setting the tri-state register bit to logic [1], the input is high-impedance regardless of the wetting command setting. The configurable comparator (4.0 V default) on each input remains active. The MCU may change or update the tri-state register via software at any time in Normal mode. The tri-state register defaults to 1 (inputs are tristated). Any input in tri-state is still polled in LPM but the current source is not active during this time. The determination of change of state occurs at the end of the $t_{ACTIVEPOLL}$ and the wake-up decision is made.

Table 13. Tri-state SG register

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|---------------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0000_011 | 0/1 | FAULT STATUS | INTflg | Unused | SG20 | SG19 | SG18 | SG17 | SG16 |
| Default on POR | | X | X | 0 | 1 | 1 | 1 | 1 | 1 |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit 11 | bit 10 | bit 9 | bit 8 |
| | | SG15 | SG14 | SG13 | SG12 | SG11 | SG10 | SG9 | SG8 |
| | | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 |
| | | bit 7 | bit 6 | bit 5 | bit 4 | bit 3 | bit 2 | bit 1 | bit 0 |
| | | SG7 | SG6 | SG5 | SG4 | SG3 | SG2 | SG1 | SG0 |
| | | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 |
| MISO Return Word | | bit 23 | bit 22 | bits [21 - 0] | | | | | |
| 0000_011[R/W] | | FAULT STATUS | INTflg | Register Data | | | | | |

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8.9.5 Wetting current level SP register 0

Three bits are used to control the configurable wetting currents for each individual input pin with the values set in the [Table 20](#). The default configuration is 16 mA for all channels. The MCU may change or update the wetting current register via software at any time in Normal mode.

Table 14. Wetting current level SP register 0

| Register address | R/W | SPI data bits [23 - 0] | | | | | | |
|------------------|------|------------------------|---------------|-------------|---------------|--------------|---------------|---------|
| [31-25] | [24] | bit [23 - 21] | | | bit [20 - 18] | | bit [17 - 16] | |
| 0000_100 | 0/1 | SP7 [2-0] | | | SP6[2-0] | | SP5[2-1] | |
| Default on POR | | 110 | | | 110 | | 11 | |
| | | bit [15] | bit [14 - 12] | | | bit [11 - 9] | | bit [8] |
| | | SP5[0] | SP4 [2-0] | | | SP3[2-0] | | SP2[2] |
| | | 0 | 110 | | | 110 | | 1 |
| | | bit [7 - 6] | | bit [5 - 3] | | | bit [2 - 0] | |
| | | SP2[1-0] | | SP1[2-0] | | | SP0[2-0] | |
| | | 10 | | 110 | | | 110 | |
| MISO Return Word | | bits [23 - 0] | | | | | | |
| 0000_100[R/W] | | Register Data | | | | | | |

See [Table 25](#) for the selectable wetting current level values for both SPx and SGx pins.

8.9.6 Wetting current level SP register 1

Three bits are used to control the configurable wetting currents for each individual input pin with the values set in the [Table 21](#). The default configuration is 16 mA for all channels. The MCU may change or update the wetting current register via software at any time in Normal mode.

Table 15. Wetting current level SP register 1

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|---------------|--------|--------------|-------------|--------|---------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0001_000 | 0/1 | FAULT STATUS | INTflg | Unused | | | | | |
| Default on POR | | X | X | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit [11 - 9] | | | bit [8] |
| | | Unused | | | | SP11[2-0] | | | SP10[2] |
| | | 0 | 0 | 0 | 0 | 110 | | | 1 |
| | | bit [7 - 6] | | bit [5 - 3] | | | bit [2 - 0] | | |
| | | SP10[1-0] | | SP9[2-0] | | | SP8[2-0] | | |
| | | 10 | | 110 | | | 110 | | |
| MISO Return Word | | bit 23 | bit 22 | bits [21 - 0] | | | | | |
| 0001_000[R/W] | | FAULT STATUS | INTflg | Register Data | | | | | |

See [Table 25](#) for the selectable wetting current level values for both SPx and SGx pins.

8.9.7 Wetting current level SG register 0

Three bits are used to control the configurable wetting currents for each individual input pin with the values set in the [Table 22](#). The default configuration is 16 mA for all channels. The MCU may change or update the wetting current register via software at any time in Normal mode.

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Table 16. Wetting current level SG register 0

| Register address | R/W | SPI data bits [23 - 0] | | | | | | |
|------------------|------|------------------------|---------------|-------------|---------------|--------------|---------------|---------|
| [31-25] | [24] | bit [23 - 21] | | | bit [20 - 18] | | bit [17 - 16] | |
| 0000_101 | 0/1 | SG7 [2-0] | | | SG6[2-0] | | SG5[2-1] | |
| Default on POR | | 110 | | | 110 | | 11 | |
| | | bit [15] | bit [14 - 12] | | | bit [11 - 9] | | bit [8] |
| | | SG5[0] | SG4 [2-0] | | | SG3[2-0] | | SG2[2] |
| | | 0 | 110 | | | 110 | | 1 |
| | | bit [7 - 6] | | bit [5 - 3] | | | bit [2 - 0] | |
| | | SG2[1-0] | | SG1[2-0] | | | SG0[2-0] | |
| | | 10 | | 110 | | | 110 | |
| MISO Return Word | | bits [23 - 0] | | | | | | |
| 0000_101[R/W] | | Register Data | | | | | | |

See [Table 25](#) for the selectable wetting current level values for both SPx and SGx pins.

8.9.8 Wetting current level SG register 1

Three bits are used to control the configurable wetting currents for each individual input pin with the values set in the [Table 23](#). The default configuration is 16 mA for all channels. The MCU may change or update the wetting current register via software at any time in Normal mode.

Table 17. Wetting current level SG register 1

| Register address | R/W | SPI data bits [23 - 0] | | | | | |
|------------------|------|------------------------|---------------|---------------|--------------|---------------|---------|
| [31-25] | [24] | bit [23 - 21] | | bit [20 - 18] | | bit [17 - 16] | |
| 0000_110 | 0/1 | SG15[2-0] | | SG14[2-0] | | SG13[2-1] | |
| Default on POR | | 110 | | 110 | | 11 | |
| | | bit [15] | bit [14 - 12] | | bit [11 - 9] | | bit [8] |
| | | SG13[0] | SG12 [2-0] | | SG11[2-0] | | SG10[2] |
| | | 0 | 110 | | 110 | | 1 |
| | | bit [7 - 6] | | bit [5 - 3] | | bit [2 - 0] | |
| | | SG10[1-0] | | SG9[2-0] | | SG8[2-0] | |
| | | 10 | | 110 | | 110 | |
| MISO Return Word | | bits [23 - 0] | | | | | |
| 0000_110[R/W] | | Register Data | | | | | |

See [Table 25](#) for the selectable wetting current level values for both SPx and SGx pins.

8.9.9 Wetting current level SG register 2

Three bits are used to control the configurable wetting currents for each individual input pin with the values set in the [Table 24](#). The default configuration is 16 mA for all channels. The MCU may change or update the wetting current register via software at any time in Normal mode.

Table 18. Wetting current level SG register 2

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|--------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 23 | bit 23 | bit 23 | bit 23 | bit 23 | bit 23 | bit 23 |
| 0000_111 | 0/1 | FAULT STATUS | INTflg | Unused | | | | | |

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Table 18. Wetting current level SG register 2...continued

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|---------------|-------------|--------|--------------|-------------|--------|---------|
| [31-25] | [24] | bit 23 | bit 23 | bit 23 | bit 23 | bit 23 | bit 23 | bit 23 | bit 23 |
| Default on POR | | X | X | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 15 | bit [14 - 12] | | | bit [11 - 9] | | | bit 8 |
| | | Unused | SG20 [2-0] | | | SG19[2-0] | | | SG18[2] |
| | | 0 | 110 | | | 110 | | | 1 |
| | | bit [7 - 6] | | bit [5 - 3] | | | bit [2 - 0] | | |
| | | SG18[1-0] | | SG17[2-0] | | | SG16[2-0] | | |
| | | 10 | | 110 | | | 110 | | |
| MISO Return Word | | bits [23 - 0] | | | | | | | |
| 0000_111[R/W] | | Register Data | | | | | | | |

See [Table 25](#) for the selectable wetting current level values for both SPx and SGx pins.

Table 19. SPx/SGx selectable wetting current levels

| SPx/SGx[2-0] | | | Wetting current level |
|--------------|-------|-------|-----------------------|
| bit 2 | bit 1 | bit 0 | |
| 0 | 0 | 0 | 2.0 mA |
| 0 | 0 | 1 | 6.0 mA |
| 0 | 1 | 0 | 8.0 mA |
| 0 | 1 | 1 | 10 mA |
| 1 | 0 | 0 | 12 mA |
| 1 | 0 | 1 | 14 mA |
| 1 | 1 | 0 | 16 mA |
| 1 | 1 | 1 | 20 mA |

8.9.10 Continuous wetting current SP register

Each switch input has a designated 20 ms timer. The timer starts when the specific switch input crosses the comparator threshold. When the 20 ms timer expires, the contact current is reduced from the configured wetting current (16 mA) to the sustain current. The wetting current is defined to be an elevated level reducing to the lower sustain current level after the timer has expired. With multiple wetting current timers disabled, power dissipation for the IC must be considered (see [Figure 25](#)).

The MCU may change or update the continuous wetting current register via software at any time in Normal mode. This allows the MCU to control the amount of time wetting current is applied to the switch contact. Programming the continuous wetting current bit to logic [0] operates normally with a higher wetting current followed by sustain current after 20 ms (pulsed Wetting current operation). Programming to logic [1] enables the continuous wetting current ([Table 26](#)) and result in a full time wetting current level. The continuous wetting current register defaults to 0 (pulse wetting current operation).

Table 20. Continuous wetting current SP register

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|--------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0001_011 | 0/1 | FAULT STATUS | INTflg | Unused | | | | | |

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Table 20. Continuous wetting current SP register...continued

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|---------------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| Default on POR | | X | X | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit 11 | bit 10 | bit 9 | bit 8 |
| | | Unused | | | | SP11 | SP10 | SP9 | SP8 |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 7 | bit 6 | bit 5 | bit 4 | bit 3 | bit 2 | bit 1 | bit 0 |
| | | SP7 | SP6 | SP5 | SP4 | SP3 | SP2 | SP1 | SP0 |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| MISO Return Word | | bit 23 | bit 22 | bits [21 - 0] | | | | | |
| 0001_011[R/W] | | FAULT STATUS | INTflg | Register Data | | | | | |

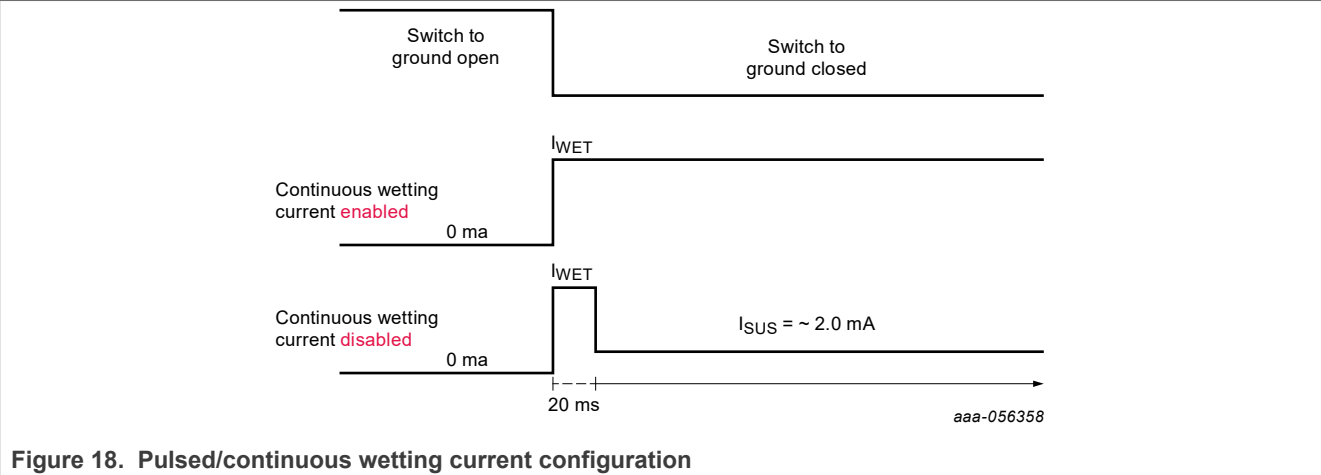
8.9.11 Continuous wetting current SG register

Each switch input has a designated 20 ms timer. The timer starts when the specific switch input crosses the comparator threshold. When the 20 ms timer expires, the contact current is reduced from the configured wetting current (16 mA) to 2.0 mA. The wetting current is defined to be at an elevated level that reduces to the lower sustain current level after the timer has expired. With multiple wetting current timers disabled, power dissipation for the IC must be considered.

The MCU may change or update the continuous wetting current register via software at any time in Normal mode. This allows the MCU to control the amount of time wetting current is applied to the switch contact. Programming the continuous wetting current bit to logic [0] operates normally with a higher wetting current followed by sustain current after 20 ms (Pulse wetting current operation). Programming to logic [1] enables the continuous wetting current ([Table 27](#)) and results in a full time wetting current level. The continuous wetting current register defaults to 0 (pulse wetting current operation).

Table 21. Continuous wetting current SG register

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|---------------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0001_100 | 0/1 | FAULT STATUS | INTflg | Unused | SG20 | SG19 | SG18 | SG17 | SG16 |
| Default on POR | | X | X | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit 11 | bit 10 | bit 9 | bit 8 |
| | | SG15 | SG14 | SG13 | SG12 | SG11 | SG10 | SG9 | SG8 |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 7 | bit 6 | bit 5 | bit 4 | bit 3 | bit 2 | bit 1 | bit 0 |
| | | SG7 | SG6 | SG5 | SG4 | SG3 | SG2 | SG1 | SG0 |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| MISO Return Word | | bit 23 | bit 22 | bits [21 - 0] | | | | | |
| 0001_100[R/W] | | FAULT STATUS | INTflg | Register Data | | | | | |



8.9.12 Interrupt enable SP register

The interrupt register defines the inputs allowed to interrupt the CD1030 Normal mode. Programming the interrupt bit to logic [0] disables the specific input from generating an interrupt. Programming the interrupt bit to logic [1] enables the specific input to generate an interrupt with switch change of state. The MCU may change or update the interrupt register via software at any time in Normal mode. The Interrupt register defaults to 1 (Interrupt enabled).

Table 22. Interrupt enable SP register

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|---------------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0001_101 | 0/1 | FAULT STATUS | INTflg | Unused | | | | | |
| Default on POR | | X | X | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit 11 | bit 10 | bit 9 | bit 8 |
| | | Unused | | | | SP11 | SP10 | SP9 | SP8 |
| | | 0 | 0 | 0 | 0 | 1 | 1 | 1 | 1 |
| | | bit 7 | bit 6 | bit 5 | bit 4 | bit 3 | bit 2 | bit 1 | bit 0 |
| | | SP7 | SP6 | SP5 | SP4 | SP3 | SP2 | SP1 | SP0 |
| | | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 |
| MISO Return Word | | bit 23 | bit 22 | bits [21 - 0] | | | | | |
| 0001_101[R/W] | | FAULT STATUS | INTflg | Register Data | | | | | |

8.9.13 Interrupt enable SG register

The interrupt register defines the inputs allowed to interrupt the CD1030 Normal mode. Programming the interrupt bit to logic [0] disables the specific input from generating an interrupt. Programming the interrupt bit to logic [1] enables the specific input to generate an interrupt with switch change of state. The MCU may change or update the interrupt register via software at any time in Normal mode. The Interrupt register defaults to 1 (Interrupt enabled).

Table 23. Interrupt enable SG register

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|--------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0001_110 | 0/1 | FAULT STATUS | INTflg | Unused | SG20 | SG19 | SG18 | SG17 | SG16 |

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Table 23. Interrupt enable SG register...continued

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|---------------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| Default on POR | | X | X | 0 | 1 | 1 | 1 | 1 | 1 |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit 11 | bit 10 | bit 9 | bit 8 |
| | | SG15 | SG14 | SG13 | SG12 | SG11 | SG10 | SG9 | SG8 |
| | | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 |
| | | bit 7 | bit 6 | bit 5 | bit 4 | bit 3 | bit 2 | bit 1 | bit 0 |
| | | SG7 | SG6 | SG5 | SG4 | SG3 | SG2 | SG1 | SG0 |
| | | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 |
| MISO Return Word | | bit 23 | bit 22 | bits [21 - 0] | | | | | |
| 0001_110[R/W] | | FAULT STATUS | INTflg | Register Data | | | | | |

8.9.14 Low-power mode configuration

The device has various configuration settings for the Low-power mode operation. The configuration settings are as follows:

- int[3-0] is used to set the interrupt timer value. With the interrupt timer set, the IC wakes up after the selected timer expires and issues an interrupt. This register can be selected to be OFF such that the IC does not wake-up from an interrupt timer.
- poll[3-0] is used to set the normal polling rate for the IC. The polling rate is the time between polling events. The current sources become active at this time for a time of $t_{ACTIVEPOLLSG}$ or $t_{ACTIVEPOLLSB}$ for SG or SB channels respectively.

Table 24. Low-power mode configuration register

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|---------------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0001_111 | 0/1 | FAULT STATUS | INTflg | Unused | | | | | |
| Default on POR | | X | X | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit 11 | bit 10 | bit 9 | bit 8 |
| | | Unused | | | | | | | |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 7 | bit 6 | bit 5 | bit 4 | bit 3 | bit 2 | bit 1 | bit 0 |
| | | int3 | int2 | int1 | int0 | poll3 | poll2 | poll1 | poll0 |
| | | 0 | 0 | 0 | 0 | 1 | 1 | 1 | 1 |
| MISO Return Word | | bit 23 | bit 22 | bits [21 - 0] | | | | | |
| 0001_111[R/W] | | FAULT STATUS | INTflg | Register Data | | | | | |

Table 25. Low-power mode configuration bits definition

| Bit | Functions | Default value | Description |
|--------|--------------|---------------|---|
| 23 | FAULT STATUS | X | It is set when a fault occurs and it is cleared upon reading the fault status register with a fault event no longer present. It is a global variable and clearing the flag once clears it for all registers. |
| 22 | INTflg | X | It is set when an interrupt event occurs and it is cleared upon a read/write transaction of a register containing the INTflg. It is a global variable and clearing the flag once clears it for all registers. |
| 21 - 8 | Unused | 0 | Unused |

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Table 25. Low-power mode configuration bits definition...continued

| Bit | Functions | Default value | Description | |
|-------|-----------|---------------|--|---|
| 7 - 4 | int[3-0] | 0000 | Set the Interrupt timer value | |
| | | | <ul style="list-style-type: none">• 0000 - OFF• 0001 - 6.0 ms• 0010 - 12 ms• 0011 - 24 ms• 0100 - 48 ms• 0101 - 96 ms• 0110 - 192 ms• 0111 - 394 ms | <ul style="list-style-type: none">• 1000 - 4.0 ms• 1001 - 8.0 ms• 1010 - 16 ms• 1011 - 32 ms• 1100 - 64 ms• 1101 - 128 ms• 1110 - 256 ms• 1111 - 512 ms |
| 3 - 0 | poll[3-0] | 1111 | Set the polling rate for switch detection | |
| | | | <ul style="list-style-type: none">• 0000 - 3.0 ms• 0001 - 6.0 ms• 0010 - 12 ms• 0011 - 24 ms• 0100 - 48 ms• 0101 - 68 ms• 0110 - 76 ms• 0111 - 128 ms | <ul style="list-style-type: none">• 1000 - 32 ms• 1001 - 36 ms• 1010 - 40 ms• 1011 - 44 ms• 1100 - 52 ms• 1101 - 56 ms• 1110 - 60 ms• 1111 - 64 ms (default) |

8.9.15 Wake-up enable register SP

The wake-up register defines the inputs allowed to wake the CD1030 from Low-power mode. Programming the wake-up bit to logic [0] disables the specific input from waking the IC (Table 32). Programming the wake-up bit to logic [1] enables the specific input to wake-up with switch change of state. The MCU may change or update the wake-up register via software at any time in Normal mode. The Wake-up register defaults to 1 (wake-up enabled). If all channels (SG and SB) have the Wake-up bit disabled, the device disables the polling timer to reduce the current consumption during Low-power mode.

Table 26. Wake-up enable SP register

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|---------------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0010_000 | 0/1 | FAULT STATUS | INTflg | Unused | | | | | |
| Default on POR | | X | X | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit 11 | bit 10 | bit 9 | bit 8 |
| | | Unused | | | | SP11 | SP10 | SP9 | SP8 |
| | | 0 | 0 | 0 | 0 | 1 | 1 | 1 | 1 |
| | | bit 7 | bit 6 | bit 5 | bit 4 | bit 3 | bit 2 | bit 1 | bit 0 |
| | | SP7 | SP6 | SP5 | SP4 | SP3 | SP2 | SP1 | SP0 |
| | | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 |
| MISO Return Word | | bit 23 | bit 22 | bits [21 - 0] | | | | | |
| 0010_000[R/W] | | FAULT STATUS | INTflg | Register Data | | | | | |

8.9.16 Wake-up enable register SG

The wake-up register defines the inputs allowed to wake the CD1030 from Low-power mode. Programming the wake-up bit to logic [0] disables the specific input from waking the IC (Table 33). Programming the wake-up bit to logic [1] enables the specific input to wake-up with any switch change of state. The MCU may change or update the wake-up register via software at any time in Normal mode. The Wake-up register defaults to 1 (wake-up enabled). If all channels (SG and SB) have the Wake-up bit disabled, the device disables the polling timer to reduce the current consumption during Low-power mode.

Table 27. Wake-up enable SG register

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|---------------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0010_001 | 0/1 | FAULT STATUS | INTflg | Unused | SG20 | SG19 | SG18 | SG17 | SG16 |
| Default on POR | | X | X | 0 | 1 | 1 | 1 | 1 | 1 |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit 11 | bit 10 | bit 9 | bit 8 |
| | | SG15 | SG14 | SG13 | SG12 | SG11 | SG10 | SG9 | SG8 |
| | | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 |
| | | bit 7 | bit 6 | bit 5 | bit 4 | bit 3 | bit 2 | bit 1 | bit 0 |
| | | SG7 | SG6 | SG5 | SG4 | SG3 | SG2 | SG1 | SG0 |
| | | 1 | 1 | 1 | 1 | 1 | 1 | 1 | 1 |
| MISO Return Word | | bit 23 | bit 22 | bits [21 - 0] | | | | | |
| 0010_001[R/W] | | FAULT STATUS | INTflg | Register Data | | | | | |

8.9.17 Comparator only SP

The comparator only register allows the input comparators to be active during LPM with no polling current. In this case, the inputs can receive a digital signal on the order of the LPM clock cycle and wake-up on a change of state. This register is intended to be used for signals that are driven by an external chip and drive to 5.0 V.

Table 28. Comparator only SP register

| Register Address | R/W | SPI Data Bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|---------------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0010_010 | 0/1 | FAULT STATUS | INTflg | Unused | | | | | |
| Default on POR | | X | X | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit 11 | bit 10 | bit 9 | bit 8 |
| | | Unused | | | | SP11 | SP10 | SP9 | SP8 |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 7 | bit 6 | bit 5 | bit 4 | bit 3 | bit 2 | bit 1 | bit 0 |
| | | SP7 | SP6 | SP5 | SP4 | SP3 | SP2 | SP1 | SP0 |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| MISO Return Word | | bit 23 | bit 22 | bits [21 - 0] | | | | | |
| 0010_010[R/W] | | FAULT STATUS | INTflg | Register Data | | | | | |

8.9.18 Comparator only SG

The comparator only register allows the input comparators to be active during LPM with no polling current. In this case, the inputs can receive a digital signal on the order of the LPM clock cycle and wake-up on a change of state. This register is intended to be used for signals driven by an external chip and drive to 5.0 V.

Table 29. Comparator only SG register

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|---------------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0010_011 | 0/1 | FAULT STATUS | INTflg | Unused | SG20 | SG19 | SG18 | SG17 | SG16 |
| Default on POR | | X | X | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit 11 | bit 10 | bit 9 | bit 8 |
| | | SG15 | SG14 | SG13 | SG12 | SG11 | SG10 | SG9 | SG8 |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 7 | bit 6 | bit 5 | bit 4 | bit 3 | bit 2 | bit 1 | bit 0 |
| | | SG7 | SG6 | SG5 | SG4 | SG3 | SG2 | SG1 | SG0 |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| MISO Return Word | | bit 23 | bit 22 | bits [21 - 0] | | | | | |
| 0010_011[R/W] | | FAULT STATUS | INTflg | Register Data | | | | | |

8.9.19 LPM voltage threshold SP configuration

The CD1030 is able to use different voltage thresholds to wake-up from LPM. When configured as SG, a Logic [0] means the input uses the LPM delta voltage threshold to determine the state of the switch. A Logic [1] means the input uses the Normal threshold (VICTHR) to determine the state of the switch. When configured as an SB, it only uses the 4.0 V threshold regardless the status of the LPM voltage threshold bit. The user must ensure the correct current level is set to allow the crossing of the normal mode threshold (typ. 4.0 V).

Table 30. LPM voltage threshold configuration SP register

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|---------------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0010_100 | 0/1 | FAULT STATUS | INTflg | Unused | | | | | |
| Default on POR | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit 11 | bit 10 | bit 9 | bit 8 |
| | | Unused | | | | SP11 | SP10 | SP9 | SP8 |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 7 | bit 6 | bit 5 | bit 4 | bit 3 | bit 2 | bit 1 | bit 0 |
| | | SP7 | SP6 | SP5 | SP4 | SP3 | SP2 | SP1 | SP0 |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| MISO Return Word | | bit 23 | bit 22 | bits [21 - 0] | | | | | |
| 0010_100[R/W] | | FAULT STATUS | INTflg | Register Data | | | | | |

8.9.20 LPM voltage threshold SG configuration

The CD1030 is able to use different voltage thresholds to wake-up from LPM. A Logic 0 means the input uses the LPM delta voltage threshold to determine the state of the switch. A Logic [1] means the input uses the Normal threshold (V_{ICTHR}) to determine the state of the switch. The user must ensure the correct current level is set to allow crossing of the normal mode threshold (typ. 4.0 V).

Table 31. LPM voltage threshold configuration SG register

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|---------------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0010_101 | 0/1 | FAULT STATUS | INTflg | Unused | SG20 | SG19 | SG18 | SG17 | SG16 |
| Default on POR | | X | X | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit 11 | bit 10 | bit 9 | bit 8 |
| | | SG15 | SG14 | SG13 | SG12 | SG11 | SG10 | SG9 | SG8 |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 7 | bit 6 | bit 5 | bit 4 | bit 3 | bit 2 | bit 1 | bit 0 |
| | | SG7 | SG6 | SG5 | SG4 | SG3 | SG2 | SG1 | SG0 |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| MISO Return Word | | bit 23 | bit 22 | bits [21 - 0] | | | | | |
| 0010_101[R/W] | | FAULT STATUS | INTflg | Register Data | | | | | |

8.9.21 Polling current SP configuration

The normal polling current for LPM is 2.0 mA for SB channels and 1.0 mA for SG channels. A logic [0] selects the normal polling current for each individual channel. By writing a Logic [1], the user may choose to select the I_{WET} current value as defined in the wetting current level registers. This results in higher LPM currents, but may be used in cases when a higher polling current is needed.

Table 32. Polling current configuration SP register

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|---------------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0010_110 | 0/1 | FAULT STATUS | INTflg | Unused | | | | | |
| Default on POR | | X | X | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit 11 | bit 10 | bit 9 | bit 8 |
| | | Unused | | | | SP11 | SP10 | SP9 | SP8 |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 7 | bit 6 | bit 5 | bit 4 | bit 3 | bit 2 | bit 1 | bit 0 |
| | | SP7 | SP6 | SP5 | SP4 | SP3 | SP2 | SP1 | SP0 |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| MISO Return Word | | bit 23 | bit 22 | bits [21 - 0] | | | | | |

Table 32. Polling current configuration SP register...continued

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|---------------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0010_110[R/W] | | FAULT STATUS | INTflg | Register Data | | | | | |

8.9.22 Polling current SG configuration

A logic [0] selects the normal polling current for LPM = 1.0 mA. By writing a logic [1], the user can select the I_{WET} current value as defined in the wetting current registers for LPM. This results in higher LPM currents, but may be used in cases when a higher polling current is needed.

Table 33. Polling current configuration SG register

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|---------------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0010_111 | 0/1 | FAULT STATUS | INTflg | Unused | SG20 | SG19 | SG18 | SG17 | SG16 |
| Default on POR | | X | X | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit 11 | bit 10 | bit 9 | bit 8 |
| | | SG15 | SG14 | SG13 | SG12 | SG11 | SG10 | SG9 | SG8 |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 7 | bit 6 | bit 5 | bit 4 | bit 3 | bit 2 | bit 1 | bit 0 |
| | | SG7 | SG6 | SG5 | SG4 | SG3 | SG2 | SG1 | SG0 |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| MISO Return Word | | bit 23 | bit 22 | bits [21 - 0] | | | | | |
| 0010_111[R/W] | | FAULT STATUS | INTflg | Register Data | | | | | |

8.9.23 Slow polling SP

The normal polling rate is defined in the Low-power mode configuration register. If the user is able to poll at a slower rate (4x), the LPM current level decreases significantly. Setting the bit to [0] results in the input polling at the normal rate as selected. Setting the bit to [1] results in the input being polled at a slower frequency at 4x the normal rate.

Table 34. Slow polling SP register

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|--------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0011_000 | 0/1 | FAULT STATUS | INTflg | Unused | | | | | |

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Table 34. Slow polling SP register...continued

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|---------------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| Default on POR | | X | X | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit 11 | bit 10 | bit 9 | bit 8 |
| | | Unused | | | | SP11 | SP10 | SP9 | SP8 |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 7 | bit 6 | bit 5 | bit 4 | bit 3 | bit 2 | bit 1 | bit 0 |
| | | SP7 | SP6 | SP5 | SP4 | SP3 | SP2 | SP1 | SP0 |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| MISO Return Word | | bit 23 | bit 22 | bits [21 - 0] | | | | | |
| 0011_000[R/W] | | FAULT STATUS | INTflg | Register Data | | | | | |

8.9.24 Slow polling SG

The normal polling rate is defined in the Low-power mode configuration register. If the user is able to poll at a slower rate (4x), the LPM current level decreases significantly. Setting the bit to [0] results in the input polling at the normal rate as selected. Setting the bit to [1] results in the input being polled at a slower frequency at 4x the normal rate.

Table 35. Slow polling SG register

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|---------------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0011_001 | 0/1 | FAULT STATUS | INTflg | Unused | SG20 | SG19 | SG18 | SG17 | SG16 |
| Default on POR | | X | X | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit 11 | bit 10 | bit 9 | bit 8 |
| | | SG15 | SG14 | SG13 | SG12 | SG11 | SG10 | SG9 | SG8 |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 7 | bit 6 | bit 5 | bit 4 | bit 3 | bit 2 | bit 1 | bit 0 |
| | | SG7 | SG6 | SG5 | SG4 | SG3 | SG2 | SG1 | SG0 |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| MISO Return Word | | bit 23 | bit 22 | bits [21 - 0] | | | | | |
| 0011_001[R/W] | | FAULT STATUS | INTflg | Register Data | | | | | |

8.9.25 Wake-up debounce SP

The IC is able to extend the time the active polling takes place to ensure a true change of state has occurred in LPM, and reduce the chance noise has impacted the measurement. If this bit is [0], the IC uses a voltage difference technique to determine if a switch has changed state. If this bit is set [1], the IC debounces the measurement by continuing to source the LPM polling current for an additional 1.2 ms and take the

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measurement based on the final voltage level. This helps to ensure the switch is detected correctly in noisy systems.

Table 36. Wake-up debounce SP register

| Register Address | R/W | SPI Data Bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|---------------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0011_010 | 0/1 | FAULT STATUS | INTflg | Unused | | | | | |
| Default on POR | | X | X | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit 11 | bit 10 | bit 9 | bit 8 |
| | | Unused | | | | SP11 | SP10 | SP9 | SP8 |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 7 | bit 6 | bit 5 | bit 4 | bit 3 | bit 2 | bit 1 | bit 0 |
| | | SP7 | SP6 | SP5 | SP4 | SP3 | SP2 | SP1 | SP0 |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| MISO Return Word | | bit 23 | bit 22 | bits [21 - 0] | | | | | |
| 0011_010[R/W] | | FAULT STATUS | INTflg | Register Data | | | | | |

8.9.26 Wake-up debounce SG

The IC is able to extend the time the active polling takes place to ensure a true change of state has occurred in LPM, and reduce the chance noise has impacted the measurement. If this bit is [0], the IC uses a voltage difference technique to determine if a switch has changed state. If this bit is set [1], the IC debounces the measurement by continuing to source the LPM polling current for an additional 1.2 ms, and take the measurement based on the final voltage level. This helps to ensure the switch is detected correctly in noisy systems.

Table 37. Wake-up debounce SG register

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|---------------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0011_011 | 0/1 | FAULT STATUS | INTflg | Unused | SG20 | SG19 | SG18 | SG17 | SG16 |
| Default on POR | | X | X | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit 11 | bit 10 | bit 9 | bit 8 |
| | | SG15 | SG14 | SG13 | SG12 | SG11 | SG10 | SG9 | SG8 |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 7 | bit 6 | bit 5 | bit 4 | bit 3 | bit 2 | bit 1 | bit 0 |
| | | SG7 | SG6 | SG5 | SG4 | SG3 | SG2 | SG1 | SG0 |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| MISO Return Word | | bit 23 | bit 22 | bits [21 - 0] | | | | | |
| 0011_011[R/W] | | FAULT STATUS | INTflg | Register Data | | | | | |

8.9.27 Enter Low-power mode

Low-power mode (LPM) is used to reduce system quiescent currents. Low-power mode may be entered only by sending the Low-power command. When returning to Normal mode, all register settings are maintained.

The Enter Low-power mode register is write only and has the effect of going to LPM and beginning operation as selected (polling, interrupt timer). When returning from Low-power mode, the CD1030 returns the [Read switch status SG register](#) on the first valid SPI transaction. The user should ensure the [Read switch status SP register](#) command is sent in the first SPI transaction after POR, to get the remaining SP switch status information in the second SPI transaction.

Table 38. Enter Low-power mode command

| Register address | W | SPI data bits [23 - 0] |
|------------------|------|------------------------|
| [31-25] | [24] | bits [23 - 16] |
| 0011_100 | 1 | 0000_0000 |
| | | bits [15 - 8] |
| | | 0000_0000 |
| | | bits [7 - 0] |
| | | 0000_0000 |
| MISO Return Word | | - |

8.9.28 AMUX control register

The analog voltage on switch inputs may be read by the MCU using the analog command ([Table 45](#)). Internal to the CD1030 is a 35-to-1 analog multiplexer. The voltage present on the selected input pin is buffered and made available on the AMUX output pin. The AMUX output pin is clamped to a maximum of V_{DDQ} volts regardless of the higher voltages present on the input pin. After an input has been selected as the analog, the corresponding bit in the next MISO data stream is logic [0].

Setting the current to wetting current (configurable) may be useful for reading sensor inputs. Analog currents set by the analog command are pull-up currents for all inputs. The MCU may change or update the analog select register via software at any time in Normal mode. The analog select defaults to no input.

Table 39. AMUX control register

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|---------------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0011_101 | 0/1 | FAULT STATUS | INTflg | Unused | | | | | |
| Default on POR | | X | X | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit 11 | bit 10 | bit 9 | bit 8 |
| | | Unused | | | | | | | |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 7 | bit 6 | bit 5 | bit 4 | bit 3 | bit 2 | bit 1 | bit 0 |
| | | Unused | asett0 | asel[5-0] | | | | | |
| | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |
| MISO Return Word | | bit 23 | bit 22 | bits [21 - 0] | | | | | |

Table 39. AMUX control register...continued

| Register address | R/W | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|---------------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0011_101[R/W] | | FAULT STATUS | INTflg | Register Data | | | | | |

Table 40. AMUX current select

| asett[0] | Zsource |
|----------|------------------|
| 0 | hi Z (default) |
| 1 | I _{WET} |

Table 41. AMUX channel select

| asel 5 | asel 4 | asel3 | asel 2 | asel 1 | asel 0 | Analog channel select |
|--------|--------|-------|--------|--------|--------|-----------------------|
| 0 | 0 | 0 | 0 | 0 | 0 | No Input Selected |
| 0 | 0 | 0 | 0 | 0 | 1 | SG0 |
| 0 | 0 | 0 | 0 | 1 | 0 | SG1 |
| 0 | 0 | 0 | 0 | 1 | 1 | SG2 |
| 0 | 0 | 0 | 1 | 0 | 0 | SG3 |
| 0 | 0 | 0 | 1 | 0 | 1 | SG4 |
| 0 | 0 | 0 | 1 | 1 | 0 | SG5 |
| 0 | 0 | 0 | 1 | 1 | 1 | SG6 |
| 0 | 0 | 1 | 0 | 0 | 0 | SG7 |
| 0 | 0 | 1 | 0 | 0 | 1 | SG8 |
| 0 | 0 | 1 | 0 | 1 | 0 | SG9 |
| 0 | 0 | 1 | 0 | 1 | 1 | SG10 |
| 0 | 0 | 1 | 1 | 0 | 0 | SG11 |
| 0 | 0 | 1 | 1 | 0 | 1 | SG12 |
| 0 | 0 | 1 | 1 | 1 | 0 | SG13 |
| 0 | 0 | 1 | 1 | 1 | 1 | SG14 |
| 0 | 1 | 0 | 0 | 0 | 0 | SG15 |
| 0 | 1 | 0 | 0 | 0 | 1 | SG16 |
| 0 | 1 | 0 | 0 | 1 | 0 | SG17 |
| 0 | 1 | 0 | 0 | 1 | 1 | SG18 |
| 0 | 1 | 0 | 1 | 0 | 0 | SG19 |
| 0 | 1 | 0 | 1 | 0 | 1 | SG20 |
| 0 | 1 | 0 | 1 | 1 | 0 | SP0 |
| 0 | 1 | 0 | 1 | 1 | 1 | SP1 |

Table 41. AMUX channel select...continued

| asel 5 | asel 4 | asel3 | asel 2 | asel 1 | asel 0 | Analog channel select |
|--------|--------|-------|--------|--------|--------|-----------------------|
| 0 | 1 | 1 | 0 | 0 | 0 | SP2 |
| 0 | 1 | 1 | 0 | 0 | 1 | SP3 |
| 0 | 1 | 1 | 0 | 1 | 0 | SP4 |
| 0 | 1 | 1 | 0 | 1 | 1 | SP5 |
| 0 | 1 | 1 | 1 | 0 | 0 | SP6 |
| 0 | 1 | 1 | 1 | 0 | 1 | SP7 |
| 0 | 1 | 1 | 1 | 1 | 0 | SP8 |
| 0 | 1 | 1 | 1 | 1 | 1 | SP9 |
| 1 | 0 | 0 | 0 | 0 | 0 | SP10 |
| 1 | 0 | 0 | 0 | 0 | 1 | SP11 |
| 1 | 0 | 0 | 0 | 1 | 0 | Temp Diode |
| 1 | 0 | 0 | 0 | 1 | 1 | Battery Sense |

8.9.29 Read switch status registers

The CD1030 uses two status registers to provide the status of all 33 input channels. The [Read switch status SP register](#) is used to determine the state of each one of the SP inputs and is read only. All of the SP inputs are returned after the next command is sent. A Logic [1] means the switch is closed while a Logic [0] is an open switch.

The [Read switch status SG register](#) is used to determine the state of each one of the SG inputs and is read only. All of the SG inputs are returned after the next command is sent. A Logic [1] means the switch is closed while a Logic [0] is an open switch.

Both status registers include two more bits, the Fault Status bit and INTflg bit. The Fault Status bit is a combination of various Fault Status bits in the [Fault status register](#). If any of these bits are set, the Fault Status bit is set. The INTflg bit is set when an interrupt occurs on this device. After POR both the Fault Status bit and the INTflg bit are set high to indicate an interrupt due to a POR occurred. The CD1030 returns the [Read switch status SG register](#) on the first valid SPI transaction and the INTflg bit is cleared, the Fault Status bit remains high until the Fault status register is read and thus the POR fault bit and all other fault flags are cleared. User must ensure the [Read switch status SP register](#) command is sent in the first SPI transaction after POR in order to get the remaining SP switch status information in the second SPI transaction.

Table 42. Read switch status SP register

| Register address | R | SPI data bits [23 - 0] | | | | | | | |
|------------------|------|------------------------|--------|--------|--------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0011_110 | 0 | FAULT STATUS | INTflg | Unused | | | | | |

Table 42. Read switch status SP register...continued

| Register address | R | SPI data bits [23 - 0] | | | | | | | |
|-------------------|------|------------------------|--------|--------------|--------|-------------------------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| Default After POR | | X | X | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit 11 | bit 10 | bit 9 | bit 8 |
| | | Unused | | | | SP11 | SP10 | SP9 | SP8 |
| | | 0 | 0 | 0 | 0 | X | X | X | X |
| | | bit 7 | bit 6 | bit 5 | bit 4 | bit 3 | bit 2 | bit 1 | bit 0 |
| | | SP7 | SP6 | SP5 | SP4 | SP3 | SP2 | SP1 | SP0 |
| | | X | X | X | X | X | X | X | X |
| MISO Return Word | | bit 23 | bit 22 | bits [21-12] | | bits [11-0] | | | |
| 0011_1100 | | FAULT STATUS | INTflg | Unused | | SP11- SP0 Switch Status | | | |

Table 43. Read switch status SG register

| Register address | R | SPI data bits [23 - 0] | | | | | | | |
|-------------------|------|------------------------|--------|----------|--------------------------|--------|--------|--------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0011_111 | 0 | FAULT STATUS | INTflg | Unused | SG20 | SG19 | SG18 | SG17 | SG16 |
| Default After POR | | 1 | 1 | 0 | X | X | X | X | X |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit 11 | bit 10 | bit 9 | bit 8 |
| | | SG15 | SG14 | SG13 | SG12 | SG11 | SG10 | SG9 | SG8 |
| | | X | X | X | X | X | X | X | X |
| | | bit 7 | bit 6 | bit 5 | bit 4 | bit 3 | bit 2 | bit 1 | bit 0 |
| | | SG7 | SG6 | SG5 | SG4 | SG3 | SG2 | SG1 | SG0 |
| | | X | X | X | X | X | X | X | X |
| MISO Return Word | | bit 23 | bit 22 | bit [21] | bits [20-0] | | | | |
| 0011_1110 | | FAULT STATUS | INTflg | Unused | SG20 - SG0 Switch Status | | | | |

8.9.30 Fault status register

To read the fault status bits the user should first send a message to the IC with the fault status register address followed by any given second command. The MISO response from the second command contains the fault flag information.

Table 44. Fault status register

| Register address | R | SPI data bits [23 - 0] | | | | | | | |
|-------------------|------|------------------------|--------|-----------------|--------|------------|-------------|------------|--------|
| [31-25] | [24] | bit 23 | bit 22 | bit 21 | bit 20 | bit 19 | bit 18 | bit 17 | bit 16 |
| 0100_001 | 0 | Unused | INTflg | Unused | | | | | |
| Default After POR | | 0 | X | 0 | 0 | 0 | 0 | 0 | 0 |
| | | bit 15 | bit 14 | bit 13 | bit 12 | bit 11 | bit 10 | bit 9 | bit 8 |
| | | Unused | | | | | SPI error | Hash Fault | Unused |
| | | 0 | 0 | 0 | 0 | 0 | X | X | 0 |
| | | bit 7 | bit 6 | bit 5 | bit 4 | bit 3 | bit 2 | bit 1 | bit 0 |
| | | UV | OV | TempFlag | OT | INT_B Wake | WAKE_B Wake | SPI Wake | POR |
| | | X | X | X | X | X | X | X | X |
| MISO Return Word | | bit 23 | bit 22 | bits [21-0] | | | | | |
| 0100_0010 | | FAULT STATUS | INTflg | FAULT/FLAG BITS | | | | | |

Table 45. MISO response for fault status command

| Bit | Functions | Default value | Description |
|-------|------------|---------------|---|
| 23 | Unused | 0 | Unused |
| 22 | INTflg | X | Reports an Interrupt has occurred, user should read the status register to determine cause. • Set: Various (SGx change of state, SPx change of state, Extended status bits). • Reset: Clear of fault or read of Status register |
| 21-11 | Unused | 0 | Unused |
| 10 | SPI error | X | Any SPI error generates a bit (Wrong address, incorrect modulo). • Set: SPI message error. • Reset: Read fault status register and no SPI errors. |
| 9 | Hash Fault | X | SPI register and hash mismatch. • Set: Mismatch between SPI registers and hash. • Reset: No mismatch and SPI flag read. |
| 8 | Unused | 0 | Unused |
| 7 | UV | X | Reports a low V _{BATP} voltage was in undervoltage range • Set: Voltage drops below UV level. • Reset: VBATP rises above UV level and flag read (SPI) |
| 6 | OV | X | Report the voltage on VBATP was higher than the OV threshold • Set: Voltage at VBATP rises above overvoltage threshold. • Reset: Overvoltage condition is over and flag read (SPI) |
| 5 | Temp Flag | X | Temperature warning to note elevated IC temperature • Set: t _{LIM} warning threshold is passed. • Reset: Temperature drops below thermal warning threshold + hysteresis and flag read (SPI) |

Table 45. MISO response for fault status command...continued

| Bit | Functions | Default value | Description |
|-----|-------------|---------------|--|
| 4 | OT | X | T_{LIM} event occurred on the IC • Set: T_{LIM} warning threshold is passed. • Reset: Temperature drops below thermal warning threshold + hysteresis and flag read (SPI) |
| 3 | INT_B Wake | X | Part awakens via an external INT_B falling edge • Set: INT_B Wakes the part from LPM (external falling edge) • Reset: flag read (SPI). |
| 2 | WAKE_B Wake | X | Part awakens via an external WAKE_B falling edge • Set: External WAKE_B falling edge seen • Reset: flag read (SPI). |
| 1 | SPI Wake | X | Part awaken via a SPI message • Set: SPI message wakes the IC from LPM • Reset: flag read (SPI). |
| 0 | POR | X | Reports a POR event occurred. • Set: Voltage at VBATP pin dropped below VBATP(POR) voltage • Reset: flag read (SPI) |

8.9.31 Interrupt request

The MCU may request an Interrupt pulse duration of 100 μ s by sending the Interrupt request command. After an Interrupt request command, the CD1030 returns the Interrupt request command word, as well as the Fault status and INTflg bits set, if a fault/interrupt event occurred. Sending an interrupt request command does not set the INTflg bit itself.

Table 46. Interrupt request command

| Register address | W | SPI data bits [23 - 0] | |
|------------------|--------------|------------------------|-------------|
| [31-25] | [24] | bits [23 - 16] | |
| 0100_011 | 1 | 0000_0000 | |
| | | bits [15 - 8] | |
| | | 0000_0000 | |
| | | bits [7 - 0] | |
| | | 0000_0000 | |
| MISO Return Word | bit 23 | bit 22 | bits [21-0] |
| 0100_0111 | FAULT STATUS | INTflg | 0x000000 |

8.9.32 Reset register

Writing to this register causes all of the SPI registers to reset. The CD1030 behaves in the same way as if a POR has occurred. Both the Fault Status bit and the INTflg bit are set high to indicate an interrupt due to a POR occurred. The CD1030 returns the [Read switch status](#) SG register on the first valid SPI transaction and the INTflg bit is cleared, the Fault Status bit remains high until the Fault status register is read and thus the POR fault bit and all other fault flags are cleared. User must ensure the [Read switch status SP register](#) command is

sent in the first SPI transaction after POR, to get the remaining SP switch status information in the second SPI transaction.

Table 47. Reset command

| Register address | W | SPI data bits [23 - 0] | | | |
|------------------|--------------|------------------------|--------|--------------------------|--|
| [31-25] | [24] | bits [23 - 16] | | | |
| 0100_100 | 1 | 0000_0000 | | | |
| | | bits [15 - 8] | | | |
| | | 0000_0000 | | | |
| | | bits [7 - 0] | | | |
| | | 0000_0000 | | | |
| MISO Return Word | bit 23 | bit 2 | bit 21 | bits [20-0] | |
| 0011_1110 | FAULT STATUS | INTflg | Unused | SG20 - SG0 Switch Status | |

9 General product characteristics

9.1 Maximum ratings

Table 48. Maximum ratings

All voltages are with respect to ground unless otherwise noted. Exceeding these ratings may cause a malfunction or permanent damage to the device.

| Symbol | Description (Rating) | Min. | Max. | Unit | Notes |
|--|---|--------------------|---|------|--------------------|
| Electrical Ratings | | | | | |
| VBATP | Battery Voltage | -0.3 | 40 | V | |
| VDDQ | Supply Voltage | -0.3 | 7.0 | V | |
| CS_B, MOSI, MISO, SCLK | SPI Inputs/Outputs | -0.3 | 7.0 | V | |
| SGx, SPx | Switch Input Range | -14 ⁽²⁾ | 38 | V | |
| AMUX | AMUX | -0.3 | 7.0 | V | |
| INT_B | INT_B | -0.3 | 7.0 | V | |
| WAKE_B | WAKE_B | -0.3 | 40 | V | |
| V _{ESD1-2} V _{ESD1-3} V _{ESD2-1} V _{ESD2-2} | ESD Voltage • Human Body Model (HBM) (VBATP versus GND) • Human Body Model (HBM) (All other pins) • Charge Device Model (CDM) (Corners pins) • Charge Device Model (CDM) (All other pins) | | ±4000 ±2000 ±750 ±500 | V | ⁽³⁾ |
| V _{ESD5-3} V _{ESD5-4} V _{ESD6-1} V _{ESD6-2} | Contact Discharge • VBATP • WAKE_B (series resistor 10 kΩ) • SGx and SPx pins with 100 nF capacitor (100 Ω series R) based on external protection performance • SGx and SPx pins with 47 nF capacitor (50 Ω series R) | | ±8000 ±8000 ±8000 ±8000 ⁽⁵⁾ | V | ^{(4),(6)} |

Notes

2. Minimum value of -18 V is guaranteed by design for switch input voltage range (SGx, SPx).

3. ESD testing is performed in accordance AEC Q100, with the Human Body Model (HBM) ($C_{ZAP} = 100$ pF, $R_{ZAP} = 1500$ Ω), the Machine Model (MM) ($C_{ZAP} = 200$ pF, $R_{ZAP} = 0$ Ω), and the Charge Device Model (CDM).

4. $C_{ZAP} = 330$ pF, $R_{ZAP} = 2.0$ kΩ (Powered and unpowered) / $C_{ZAP} = 150$ pF, $R_{ZAP} = 330$ Ω (Unpowered)

5. $C_{ZAP} = 150$ pF, $R_{ZAP} = 330$ Ω (Unpowered)

6. See [Table 4](#) for minimum external component requirements at system level.

Table 49. External component requirements

| | |
|--------------|--|
| VBATP Pin | $C_{BULK} = 100$ μF minimum aluminum electrolytic $C_{BYPASS} = 100$ nF ±37% minimum ceramic Reverse blocking diode [0.6 V < $V_{FWD} < 1.0$ V) |
| VDDQ Pin | $C_{BULK} = 10$ μF Typical aluminum electrolytic (If required by the application) $C_{BYPASS} = 100$ nF minimum ceramic |
| SGx/SPx Pins | 47 nF < $C_{ESD} < 100$ nF typ ±37% 50 Ω < $R_{ESD} < 100$ Ω typical |

Table 49. External component requirements...continued

| | |
|-------------|---|
| Switch Load | 5.0 Ω < R _{SW} < 100 Ω Lumped element, includes wire harness 100 kΩ < R _{SW} isolation < ∞ |
| AMUX Output | External capacitor at AMUX Output C _{AMUX} = 1.0 nF |

9.2 Thermal characteristics

Table 50. Thermal ratings

All voltages are with respect to ground unless otherwise noted. Exceeding these ratings may cause a malfunction or permanent damage to the device.

| Symbol | Description (Rating) | Min. | Max. | Unit | Notes |
|----------------------------------|--|------------|------------|------|---------|
| Thermal Ratings | | | | | |
| T _A T _J | Operating Temperature • Ambient • Junction | -40 -40 | 125 150 | °C | |
| T _{STG} | Storage Temperature | -65 | 150 | °C | |
| T _{PPRT} | Peak Package Reflow Temperature During Reflow | – | – | °C | |
| Thermal Resistance | | | | | |
| R _{ΘJA} | Junction-to-Ambient, Natural Convection, Single-layer Board • 48 LQFP | | 75.4 | °C/W | (7) (8) |
| R _{ΘJB} | Junction-to-Board | | 13.8 | °C/W | (9) |
| R _{ΘJC} | Junction-to-Case (Bottom) • 48 LQFP | | 1.5 | °C/W | (10) |
| Ψ _{JT} | Junction-to-Package (Top), Natural convection • 48 LQFP | | 4.7 | °C/W | (11) |
| Package Dissipation Ratings | | | | | |
| T _{SD} | Thermal Shutdown • 48 LQFP | 155 | 185 | °C | |
| T _{SDH} | Thermal Shutdown Hysteresis • 48 LQFP | 3.0 | 15 | °C | |

33-channel multiple switch detection interface with programmable wetting current

Table 50. Thermal ratings ...continued

All voltages are with respect to ground unless otherwise noted. Exceeding these ratings may cause a malfunction or permanent damage to the device.

| Symbol | Description (Rating) | Min. | Max. | Unit | Notes |
|---|--|------|---------|------|-------|
| Moisture Sensitivity Level | | | | | |
| Moisture | Moisture Sensitivity Level per AEC-Q-100 | | Level 3 | | |
| <div>Notes</div> <div>7. Junction temperature is a function of die size, on-chip power dissipation, package thermal resistance, mounting site (board) temperature, ambient temperature, air flow, power dissipation of other components on the board, and board thermal resistance.</div> <div>8. Per JEDEC JESD51-2 with natural convection for horizontally oriented board. Board meets JESD51-9 specification for 1s or 2s2p board, respectively.</div> <div>9. Thermal resistance between the die and the printed circuit board per JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.</div> <div>10. Thermal resistance between the die and the solder pad on the bottom of the package based on simulation without any interface resistance.</div> <div>11. Thermal characterization parameter indicating the temperature difference between package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JT.</div> | | | | | |

9.3 Operating conditions

This section describes the operating conditions of the device. Conditions apply to all the following data, unless otherwise noted.

Table 51. Operating conditions

All voltages are with respect to ground unless otherwise noted. Exceeding these ratings may cause a malfunction or permanent damage to the device.

| Symbol | Ratings | Min. | Max. | Unit | Notes |
|------------------------|----------------------|------|------|------|-------|
| VBATP | Battery Voltage | 4.5 | 36 | V | |
| VDDQ | Supply Voltage | 3.0 | 5.25 | V | |
| CS_B, MOSI, MISO, SCLK | SPI Inputs / Outputs | 3.0 | 5.25 | V | |
| SGx, SPx | Switch Input Range | -1.0 | 36 | V | |
| AMUX, INT_B | AMUX, INT_B | 0.0 | 5.25 | V | |
| WAKE_B | WAKE_B | 0.0 | 36 | V | |

9.4 Electrical characteristics

9.4.1 Static electrical characteristics

Table 52. Static electrical characteristics

$T_A = -40\text{ }^{\circ}\text{C}$ to $+125\text{ }^{\circ}\text{C}$, $V_{DDQ} = 3.1\text{ V}$ to 5.25 V , $V_{BATP} = 6.0\text{ V}$ to 28.0 V , unless otherwise noted.

| Symbol | Characteristic | Min. | Typ. | Max. | Units | Notes |
|---|---|----------------------|--------|----------|---------------|-----------|
| Power Input | | | | | | |
| $V_{BATP(POR)}$ | VBATP Supply Voltage POR • VBATP Supply Power on Reset voltage | 2.7 | 3.3 | 3.8 | V | |
| V_{BATPUV} | VBATP Undervoltage Rising Threshold | — | 4.3 | 4.5 | V | |
| $V_{BATPUVHYS}$ | VBATP Undervoltage Hysteresis | 250 | — | 500 | mV | |
| V_{BATPOV} | VBATP Overvoltage Rising Threshold | 32 | — | 37 | V | |
| $V_{BATPOVHYS}$ | VBATP Overvoltage Hysteresis | 1.5 | — | 3.0 | V | |
| $I_{BAT(on)}$ | VBATP Supply Current • All switches open, Normal mode, Tri-state disabled all channels | — | 12 | 16 | mA | |
| $I_{BATP,IQ,LPM,P}$ $I_{BATP,IQ,LPM,F}$ | VBATP Low-power Mode Supply Current (polling disabled) • Parametric V_{BATP} , $6.0\text{ V} < V_{BATP} < 28\text{ V}$ • Functional Low V_{BATP} , $4.5\text{ V} < V_{BATP} < 6.0\text{ V}$ | — — | — — | 60 60 | μA | (14) |
| $I_{POLLING,IQ}$ | VBATP Polling Quiescent Current (no load) • Polling rate = 3.0 ms • Wake-up enable all channels • All switches open | — | — | 20 | μA | (12) (13) |
| $I_{VDDQ,NORMAL}$ | Normal Mode (I_{VDDQ}) • SCLK, MOSI, WAKE_B = 0 V, CS_B, INT_B = V_{DDQ} , no SPI communication, AMUX selected no input | — | — | 500 | μA | |
| $I_{VDDQ,LPM}$ | Logic Low-power Mode Supply Current • SCLK, MOSI = 0 V, CS_B, INT_B, WAKE_B = V_{DDQ} , no SPI communication | — | — | 10 | μA | |
| $V_{DDQ_{UV}}$ | VDDQ Undervoltage Falling Threshold | 2.2 | — | 2.8 | V | |
| $V_{DDQ_{UVHYS}}$ | VDDQ Undervoltage Hysteresis | 150 | — | 350 | mV | |
| $V_{GNDOFFSET}$ | Ground Offset • Ground offset of Global pins to IC ground | -1.0 | — | 1.0 | V | |
| Switch Detection Interface (SG and SP) | | | | | | |
| V_{ICTHR} | Switch Detection Threshold | 3.7 | 4.0 | 4.3 | V | (20) |
| $V_{ICTHRLV}$ | Switch Detection Threshold Low Battery • VBATP 4.5 V to 6.0 V | 0.55 * V_{BATP} | — | 4.3 | V | |
| $V_{ICTHRLPM}$ | Switch Detection Threshold Low-power Mode (SG only) | 100 | — | 300 | mV | (21) |
| V_{ICTHRH} | Switch Detection Threshold Hysteresis (4.0 V threshold) | 80 | — | 300 | mV | |
| $V_{ICTH2P5}$ | Input Threshold 2.5 V, • Used for Comp Only | 2.0 | 2.5 | 3.0 | V | |

33-channel multiple switch detection interface with programmable wetting current

Table 52. Static electrical characteristics...continued

$T_A = -40\text{ }^{\circ}\text{C}$ to $+125\text{ }^{\circ}\text{C}$, $V_{DDQ} = 3.1\text{ V}$ to 5.25 V , $V_{BATP} = 6.0\text{ V}$ to 28.0 V , unless otherwise noted.

| Symbol | Characteristic | Min. | Typ. | Max. | Units | Notes |
|---|--|---|---|---|---------------|-----------------------------------|
| Switch to ground Input (SG pins) | | | | | | |
| I_{LEAKSG_GND} | Leakage to GND • Inputs tristated, voltage at SGx = 36 V; $V_{BATP} = 0\text{ V}$ | — | — | 2.0 | μA | |
| I_{LEAKSG_BAT} | Leakage to Battery • Inputs tristated, voltage at SGx = GND | — | — | 2.0 | μA | |
| $I_{SUS SG}$ | SG Sustain Current • $V_{BATP} 6.0\text{ V}$ to 28 V | 1.6 | 2.0 | 2.4 | mA | |
| $I_{SUS SGLV}$ | SG Sustain Current LV ⁽¹⁵⁾ • $V_{BATP} 4.5\text{ V}$ to 6.0 V | 1.0 | — | 2.4 | mA | |
| I_{WETSG} | Wetting Current Level • Mode 0 = 2.0 mA • Mode 1 = 6.0 mA • Mode 2 = 8.0 mA • Mode 3 = 10 mA • Mode 4 = 12 mA • Mode 5 = 14 mA • Mode 6 = 16 mA • Mode 7 = 20 mA | — | 2.0 6.0 8.0 10 12 14 16 20 | — | mA | |
| $I_{WETSGTOL}$ | SG Wetting Current Tolerance • Mode 0 • Mode 1 to 7 | -20 -10 | — — | 20 10 | % | |
| $I_{WETSGLV}$ | SG Wetting Current Tolerance LV ($V_{BATP} 4.5\text{ V}$ to 6.0 V) ⁽¹⁵⁾ • Mode 0 = 2.0 mA • Mode 1 = 6.0 mA • Mode 2 = 8.0 mA • Mode 3 = 10 mA • Mode 4 = 12 mA • Mode 5 = 14 mA • Mode 6 = 16 mA • Mode 7 = 20 mA | 1.0 2.0 2.0 2.0 2.0 2.0 2.0 2.0 2.0 | — — — — — — — — — | 2.4 6.6 8.8 11.0 13.2 15.4 17.6 22.0 | mA | |
| $I_{MATCH(SUS)}$ | Sustain Current Matching Between SG Channels | — | — | 10 | % | ⁽¹⁶⁾ , ⁽¹⁷⁾ |
| $I_{MATCH(WET)}$ | Wetting Current Matching Between SG Channels | — | — | 6.0 | % | ⁽¹⁸⁾ , ⁽¹⁹⁾ |
| $I_{ACTIVEPOLLSG}$ | Low-power Mode Polling Current SG • $V_{BATP} 4.5\text{ V}$ to 28 V | 0.7 | 1.0 | 1.44 | mA | |

33-channel multiple switch detection interface with programmable wetting current

Table 52. Static electrical characteristics...continued

 $T_A = -40\text{ }^{\circ}\text{C}$ to $+125\text{ }^{\circ}\text{C}$, $V_{DDQ} = 3.1\text{ V}$ to 5.25 V , $V_{BATP} = 6.0\text{ V}$ to 28.0 V , unless otherwise noted.

| Symbol | Characteristic | Min. | Typ. | Max. | Units | Notes |
|-------------------------------------|--|--|--|---|---------------|------------|
| Programmable Input (SP pins) | | | | | | |
| I_{LEAKSP_GND} | Leakage to GND • Inputs tristated, voltage at SPx = 36 V; $V_{BATP} = 0\text{ V}$ | — | — | 2.0 | μA | |
| I_{LEAKSP_BAT} | Leakage to Battery • Inputs tristated, voltage at SPx = GND | — | — | 2.0 | μA | |
| I_{SUSSP} | SP Sustain current ($V_{BATP} 6.0\text{ V}$ to 28 V) • SP programmed as SG • SP programmed as SB | 1.6 1.75 | 2.0 2.2 | 2.4 2.85 | mA | |
| $I_{SUSSPLV}$ | SP Sustain current - LV ($V_{BATP} 4.5\text{ V}$ to 6.0 V) • SP programmed as SG | 1.0 | — | 2.4 | mA | (15) |
| I_{WET0SP} | Wetting Current Level Mode 0 • SP programmed as SG • SP programmed as SB | — — | 2.0 2.2 | — — | mA | |
| I_{WETSP} | Wetting Current Level (SG & SB) • Mode 1 = 6.0 mA • Mode 2 = 8.0 mA • Mode 3 = 10 mA • Mode 4 = 12 mA • Mode 5 = 14 mA • Mode 6 = 16 mA • Mode 7 = 20 mA | — | 6.0 8.0 10 12 14 16 20 | — | mA | |
| $I_{WETSP\text{TOL}}$ | Wetting Current Tolerance • SG/SB Mode 0 • SG Mode 1 to 7 • SB Mode 1 to 7 | -20 -10 -20 | — — — | 20 10 20 | % | |
| $I_{WETSP\text{LV}}$ | Wetting Current Tolerance - LV ($V_{BATP} 4.5\text{ V}$ to 6.0 V) (SG configuration) • Mode 0 = 2.0 mA • Mode 1 = 6.0 mA • Mode 2 = 8.0 mA • Mode 3 = 10 mA • Mode 4 = 12 mA • Mode 5 = 14 mA • Mode 6 = 16 mA • Mode 7 = 20 mA Wetting Current Tolerance - LV ($V_{BATP} 4.5\text{ V}$ to 6.0 V) (SB configuration) • Mode 0 to 7 = 20 mA | 1.0 2.0 2.0 2.0 2.0 2.0 2.0 2.0 2.0 -20 | — — — — — — — — — — | 2.4 6.6 8.8 11.0 13.2 15.4 17.6 22.0 20 | mA % | (15) |
| $I_{MATCHSUSSP}$ | Sustain Current Matching Between SP Channels | — | — | 10 | % | (16), (17) |
| $I_{MATCHWETSP}$ | Wetting Current Matching Between SP Channels | — | — | 6.0 | % | (18), (19) |
| $I_{ACTIVEPOLLSP}$ | Low-power Mode Polling Current • SP programmed as SG • SP Programmed as SB | 0.7 1.75 | 1.0 2.2 | 1.44 2.85 | mA | |

33-channel multiple switch detection interface with programmable wetting current

Table 52. Static electrical characteristics...continued

 $T_A = -40\text{ }^{\circ}\text{C}$ to $+125\text{ }^{\circ}\text{C}$, $V_{DDQ} = 3.1\text{ V}$ to 5.25 V , $V_{BATP} = 6.0\text{ V}$ to 28.0 V , unless otherwise noted.

| Symbol | Characteristic | Min. | Typ. | Max. | Units | Notes |
|--------------------------------|---|------------------|------|-----------------|------------------------------|-------|
| Digital Interface | | | | | | |
| I_{HZ} | Tri-state Leakage Current (MISO) • $V_{DDQ} = 0.0$ to V_{DDQ} | -2.0 | — | 2.0 | μA | |
| $V_{INLOGIC}$ | Input Logic Voltage Thresholds • SI, SCLK, CS_B, INT_B | $V_{DDQ} * 0.25$ | — | $V_{DDQ} * 0.7$ | V | |
| $V_{INLOGICHYS}$ | Input Logic Hysteresis • SI, SCLK, CS_B, INT_B | 300 | — | — | mV | |
| $V_{INLOGICWAKE}$ | Input Logic Voltage Threshold WAKE_B | 0.8 | 1.25 | 1.7 | V | |
| V_{INWAKE_BHYS} | Input Logic Voltage Hysteresis WAKE_B | 200 | — | 800 | mV | |
| I_{SCLK}, I_{MOSI} | SCLK / MOSI Input Current • SCLK / MOSI = 0 V | -3.0 | — | 3.0 | μA | |
| I_{SCLK}, I_{MOSI} | SCLK / MOSI Pull-down Current • SCLK / MOSI = V_{DDQ} | 30 | — | 100 | μA | |
| I_{CS_BH} | CS_B Input Current • CS_B = V_{DDQ} | -10 | — | 10 | μA | |
| R_{CS_BL} | CS_B Pull-up Resistor to V_{DDQ} • CS_B = 0.0 V | 40 | 125 | 270 | $k\Omega$ | |
| V_{OHMISO} | MISO High-side Output Voltage • $I_{OHMISO} = -1.0\text{ mA}$ | $V_{DDQ} - 0.8$ | — | V_{DDQ} | V | |
| V_{OLMISO} | MISO Low-side Output Voltage • $I_{OLMISO} = 1.0\text{ mA}$ | — | — | 0.4 | V | |
| C_{IN} | Input Capacitance on SCLK, MOSI, Tri-state MISO (GBD) | — | — | 20 | pF | |
| Analog MUX Output | | | | | | |
| V_{OFFSET} | Input Offset Voltage When Selected as Analog | -15 | — | 15 | mV | |
| V_{OLAMUX} | Analog Operational Amplifier Low Output Voltage • Sink 1.0 mA | — | — | 50 | mV | |
| V_{OHAMUX} | Analog Operational Amplifier High Output Voltage • Source 1.0 mA | $V_{DDQ} - 0.1$ | — | — | V | |
| AMUX Selectable Outputs | | | | | | |
| Temp-Coeff | Chip Temperature Sensor Coefficient | — | 8.0 | — | $\text{mV}/^{\circ}\text{C}$ | |
| $V_{BATSNSACC}$ | Battery Sense (SG5 config) Accuracy • Battery voltage (SG5 input) divided by 6 • Accuracy over full temperature range | -5.0 | — | 5.0 | % | |
| $V_{BATSNSDIV}$ | Divider By 6 coefficient accuracy • Offset over operating voltage range ($V_{BATP} = 6.0\text{ V}$ to 28 V) | -3.0 | — | 3.0 | % | (22) |
| INT_B | | | | | | |
| V_{OLINT} | INT_B Output Low Voltage • $I_{OUT} = 1.0\text{ mA}$ | — | 0.2 | 0.5 | V | |
| V_{OHINT} | INT_B Output High Voltage • INT_B = Open-circuit | $V_{DDQ} - 0.5$ | — | V_{DDQ} | V | |
| R_{PU} | Pull-up Resistor to V_{DDQ} | 40 | 125 | 270 | $k\Omega$ | |
| $I_{LEAKINT_B}$ | Leakage Current INT_B • INT_B pulled up to V_{DDQ} | — | — | 1.0 | μA | |

33-channel multiple switch detection interface with programmable wetting current

Table 52. Static electrical characteristics...continued

$T_A = -40\text{ }^{\circ}\text{C}$ to $+125\text{ }^{\circ}\text{C}$, $V_{DDQ} = 3.1\text{ V}$ to 5.25 V , $V_{BATP} = 6.0\text{ V}$ to 28.0 V , unless otherwise noted.

| Symbol | Characteristic | Min. | Typ. | Max. | Units | Notes |
|--------------------------|--|-----------------|------|-----------|--------------------|-------|
| Temperature Limit | | | | | | |
| t_{FLAG} | Temperature Warning • First flag to trip | 105 | 120 | 135 | $^{\circ}\text{C}$ | |
| t_{LIM} | Temperature Monitor | 155 | — | 185 | $^{\circ}\text{C}$ | (23) |
| $t_{LIM(HYS)}$ | Temperature Monitor Hysteresis | 5.0 | — | 15 | $^{\circ}\text{C}$ | (23) |
| WAKE_B | | | | | | |
| $R_{WAKE_B(RPU)}$ | WAKE_B Internal pull-up Resistor to VDDQ | 40 | 125 | 270 | k Ω | |
| $V_{WAKE_B(VOH)}$ | WAKE_B Voltage High • WAKE_B = Open-circuit | $V_{DDQ} - 1.0$ | — | V_{DDQ} | V | |
| $V_{WAKE_B(VOL)}$ | WAKE_B Voltage Low • WAKE_B = 1.0 mA (R_{PU} to $V_{BATP} = 16\text{ V}$) | — | — | 0.4 | V | |
| I_{WAKE_BLEAK} | WAKE_B Leakage • WAKE_B pulled up to $V_{BATP} = 16\text{ V}$ through 10 k Ω | — | — | 1.0 | μA | |

Notes

12. Guaranteed by design

13. Polling quiescent current refers to the additional current in low-power mode due to the polling mechanism without any loading.

$I_{POLLING,IQ}$ depends directly on the Polling rate and it increases as the polling pulse is more frequent. Worst case scenario is polling rate = 3.0 ms, with all channels set to wake-up enable.

14. Total maximum quiescent current with polling enabled in LPM is given by $I_{BATP,LPM,IQ} + I_{POLLING,IQ}$

15. During low voltage range operation SG wetting current may be limited when there is not enough headroom between V_{BATP} and SG pin voltage.

16. $(I_{SUS(MAX)} - I_{SUS(MIN)}) \times 100 / I_{SUS(MIN)}$

17. Sustain current source (SGs only)

18. $(I_{WET(MAX)} - I_{WET(MIN)}) \times 100 / I_{WET(MIN)}$

19. Wetting current source (SGs only)

20. The input comparator threshold decreases when $V_{BATP} \leq 6.0\text{ V}$.

21. SP (as SB) only use the 4.0 V V_{ICTHR} for LPM wake-up detection.

22. Calibration of divider ratio can be done at $V_{BAT} = 12\text{ V}$, $25\text{ }^{\circ}\text{C}$ to achieve a higher accuracy. See Figure 4 for AMUX offset linearity waveform through the operating voltage range.

23. Guaranteed by characterization in the development phase, parameter not tested.

9.4.2 Dynamic electrical characteristics

Table 53. Dynamic electrical characteristics

$T_A = -40\text{ }^{\circ}\text{C}$ to $+125\text{ }^{\circ}\text{C}$. $V_{DDQ} = 3.1\text{ V}$ to 5.25 V , $V_{BATP} = 4.5\text{ V}$ to 28 V , unless otherwise specified. SPI timing is performed with a 100 pF load on MISO, unless otherwise noted.

| Symbol | Parameter | Min. | Typ. | Max. | Units | Notes |
|--------------------------------|---|-------------|-----------|-------------|---------------------|-------|
| General | | | | | | |
| t_{ACTIVE} | POR to Active time • Undervoltage to Normal mode | 250 | 340 | 450 | μs | |
| Oscillator | | | | | | |
| $\text{OSC}_{\text{TOLNOR}}$ | Oscillator Tolerance Normal Mode at 4.0 MHz | -15 | — | 15 | % | |
| $\text{OSC}_{\text{TOLLPM}}$ | Oscillator Tolerance at 192 kHz in Low-power Mode | -15 | — | 15 | % | |
| Switch Input | | | | | | |
| $t_{\text{PULSE(ON)}}$ | Pulse Wetting Current Timer • Normal mode | 17 | 20 | 23 | ms | |
| $t_{\text{INT-DLY}}$ | Interrupt Delay Time • Normal mode | — | — | 18.5 | μs | |
| $t_{\text{POLLING_TIMER}}$ | Polling Timer Accuracy • Low-power mode | — | — | 15 | % | |
| $t_{\text{INT-TIMER}}$ | Interrupt Timer Accuracy • Low-power mode | — | — | 15 | % | |
| $t_{\text{ACTIVEPOLLSG}}$ | Tactivepoll Timer SG | 49.5 | 58 | 66.5 | μs | |
| $t_{\text{ACTIVEPOLLSB}}$ | Tactivepoll Timer SB • SBPOLLTIME=0 • SBPOLLTIME=1 | 1.0 49.5 | 1.2 58 | 1.4 66.5 | ms μs | |
| $t_{\text{GLITCHTIMER}}$ | Input Glitch Filter Timer • Normal mode | 5.0 | — | 18 | μs | |
| t_{DEBOUNCE} | LPM Debounce Additional Time • Low-power mode | 1.0 | 1.2 | 1.4 | ms | |
| AMUX Output | | | | | | |
| $\text{AMUX}_{\text{VALID}}$ | AMUX Access Time (Selected Output to Selected Output) • $C_{\text{MUX}} = 1.0\text{ nF}$, Rising edge of CS_B to selected | — | (25) | — | μs | |
| $\text{AMUX}_{\text{VALIDTS}}$ | AMUX Access Time (Tristate to ON) • $C_{\text{MUX}} = 1.0\text{ nF}$, Rising edge of CS_B to selected | — | — | 20 | μs | |
| Interrupt | | | | | | |
| $\text{INT}_{\text{PULSE}}$ | Interrupt Pulse Duration • Interrupt occurs or INT_B request | 90 | 100 | 110 | μs | |

33-channel multiple switch detection interface with programmable wetting current

Table 53. Dynamic electrical characteristics...continued

$T_A = -40\text{ }^{\circ}\text{C}$ to $+125\text{ }^{\circ}\text{C}$. $V_{DDQ} = 3.1\text{ V}$ to 5.25 V , $V_{BATP} = 4.5\text{ V}$ to 28 V , unless otherwise specified. SPI timing is performed with a 100 pF load on MISO, unless otherwise noted.

| Symbol | Parameter | Min. | Typ. | Max. | Units | Notes |
|----------------------|---|------|------|------|-------|-------|
| SPI Interface | | | | | | |
| f_{OP} | Transfer Frequency | — | — | 8.0 | MHz | |
| t_{SCK} | SCLK Period • Figure 7 - 1 | 160 | — | — | ns | |
| t_{LEAD} | Enable Lead Time • Figure 7 - 2 | 140 | — | — | ns | |
| t_{LAG} | Enable Lag Time • Figure 7 - 3 | 50 | — | — | ns | |
| t_{SCKHS} | SCLK High Time • Figure 7 - 4 | 56 | — | — | ns | |
| t_{SCKLS} | SCLK Low Time • Figure 7 - 5 | 56 | — | — | ns | |
| t_{SUS} | MOSI Input Setup Time • Figure 7 - 6 | 16 | — | — | ns | |
| t_{HS} | MOSI Input Hold Time • Figure 7 - 7 | 20 | — | — | ns | |
| t_A | MISO Access Time • Figure 7 - 8 | — | — | 116 | ns | |
| t_{DIS} | MISO Disable Time ⁽²⁴⁾ • Figure 7 - 9 | — | — | 100 | ns | |
| t_{VS} | MISO Output Valid Time • Figure 7 - 10 | — | — | 116 | ns | |
| t_{HO} | MISO Output Hold Time (No cap on MISO) • Figure 7 - 11 | 20 | — | — | ns | |
| t_{RO} | Rise Time • Figure 7 - 12 | — | — | 30 | ns | (24) |
| t_{FO} | Fall Time • Figure 7 - 13 | — | — | 30 | ns | (24) |
| t_{CSN} | CS_B Negated Time • Figure 7 - 14 | 500 | — | — | ns | |

Notes

24. Guaranteed by characterization.

25. AMUX settling time to be within the 10 mV offset specification. $AMUX_{VALID}$ is dependent of the voltage step applied on the input SGx/SPx pin or the difference between the first and second channel selected as the multiplexed analog output. See [Figure 9](#) for a typical AMUX access time versus voltage step waveform.

33-channel multiple switch detection interface with programmable wetting current

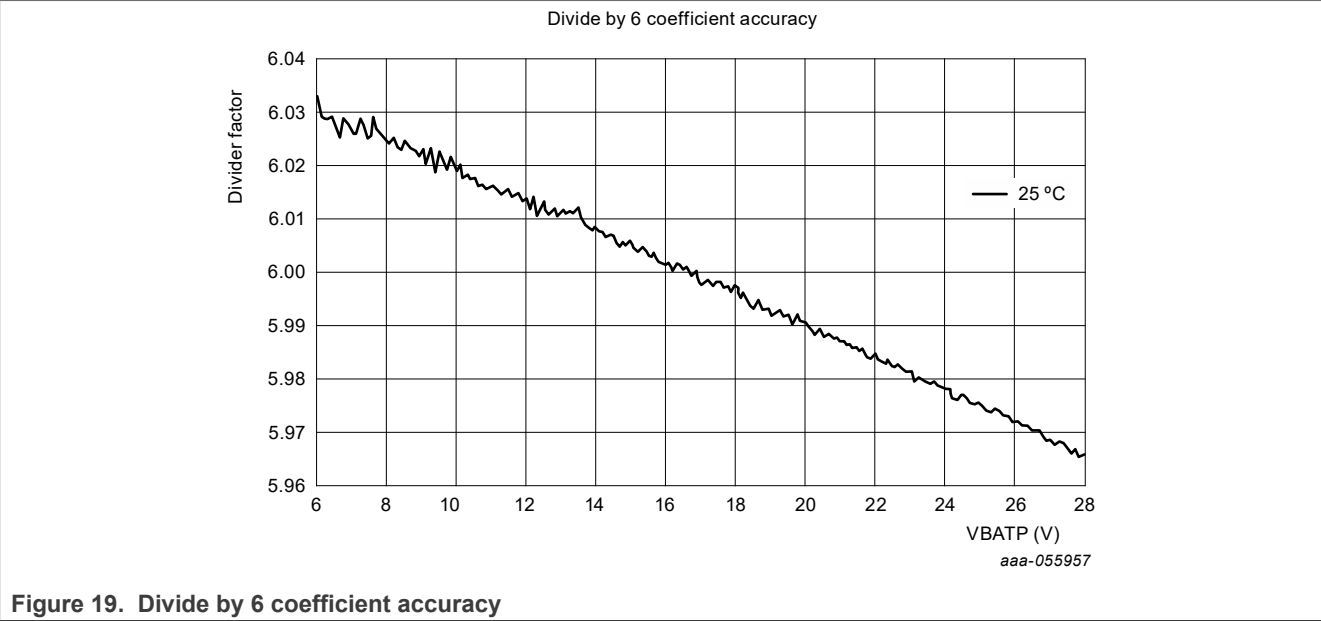


Figure 19. Divide by 6 coefficient accuracy

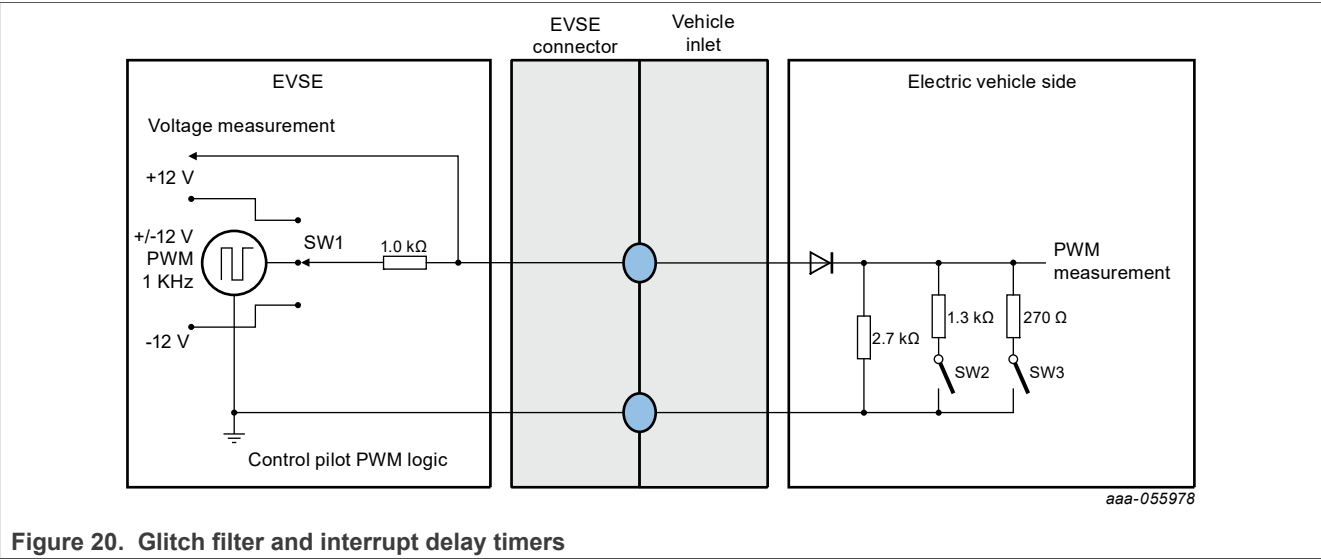


Figure 20. Glitch filter and interrupt delay timers

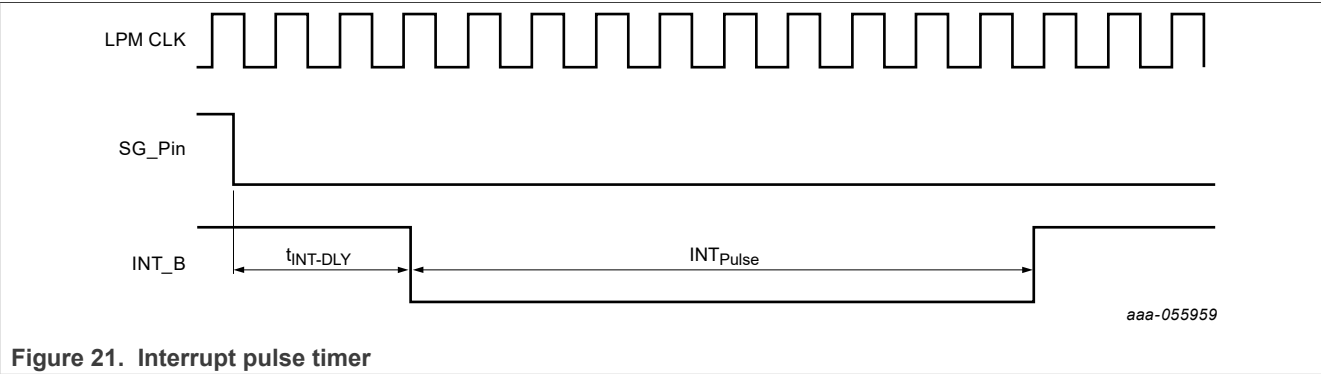


Figure 21. Interrupt pulse timer

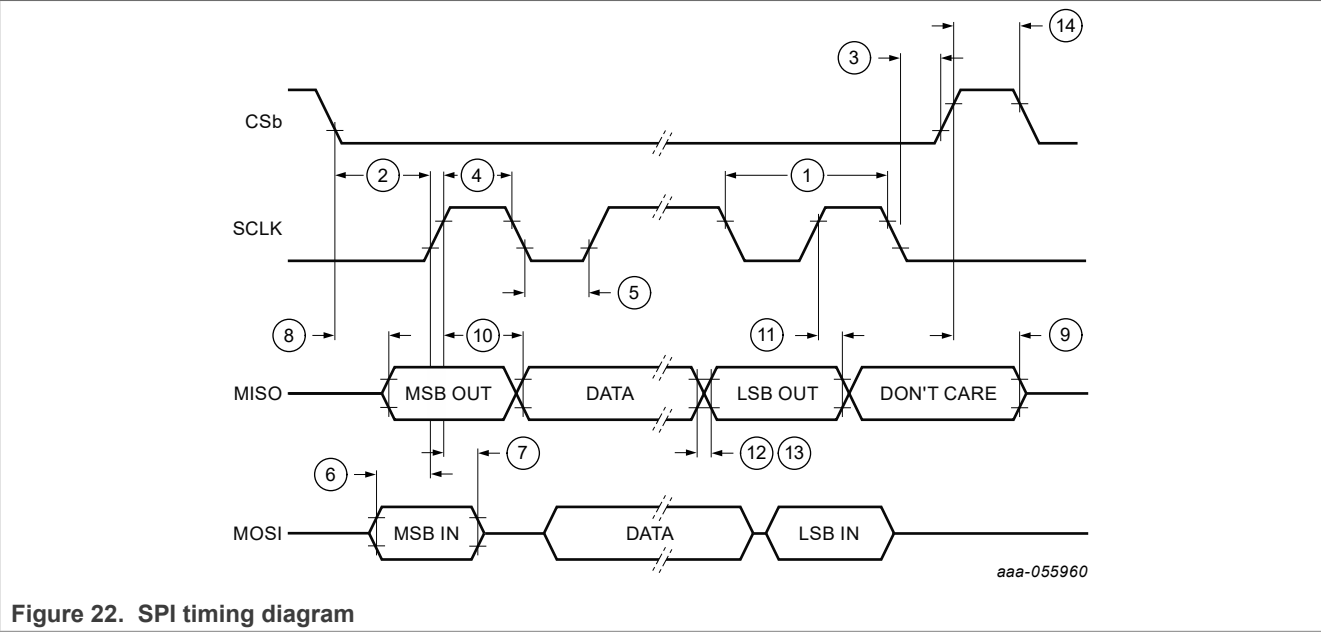


Figure 22. SPI timing diagram

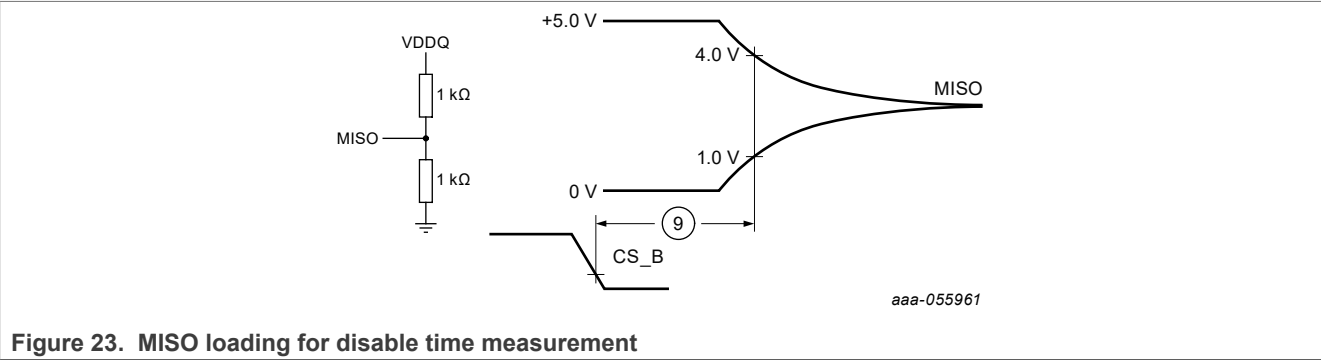


Figure 23. MISO loading for disable time measurement

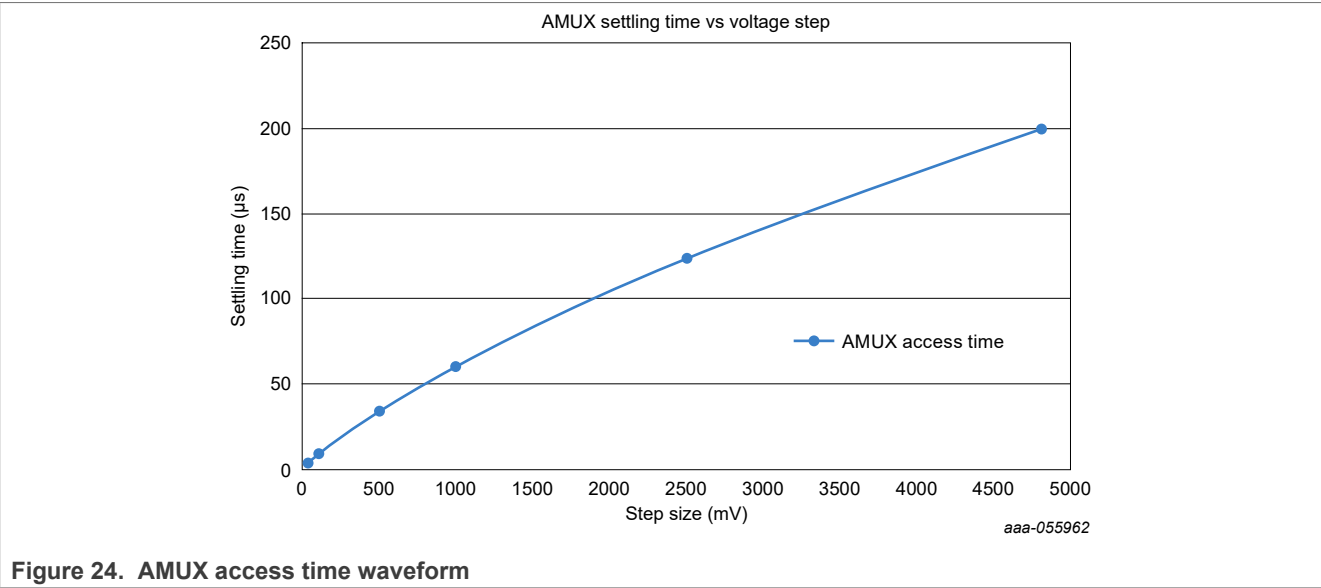


Figure 24. AMUX access time waveform

10 Typical applications

10.1 Simplified application diagram

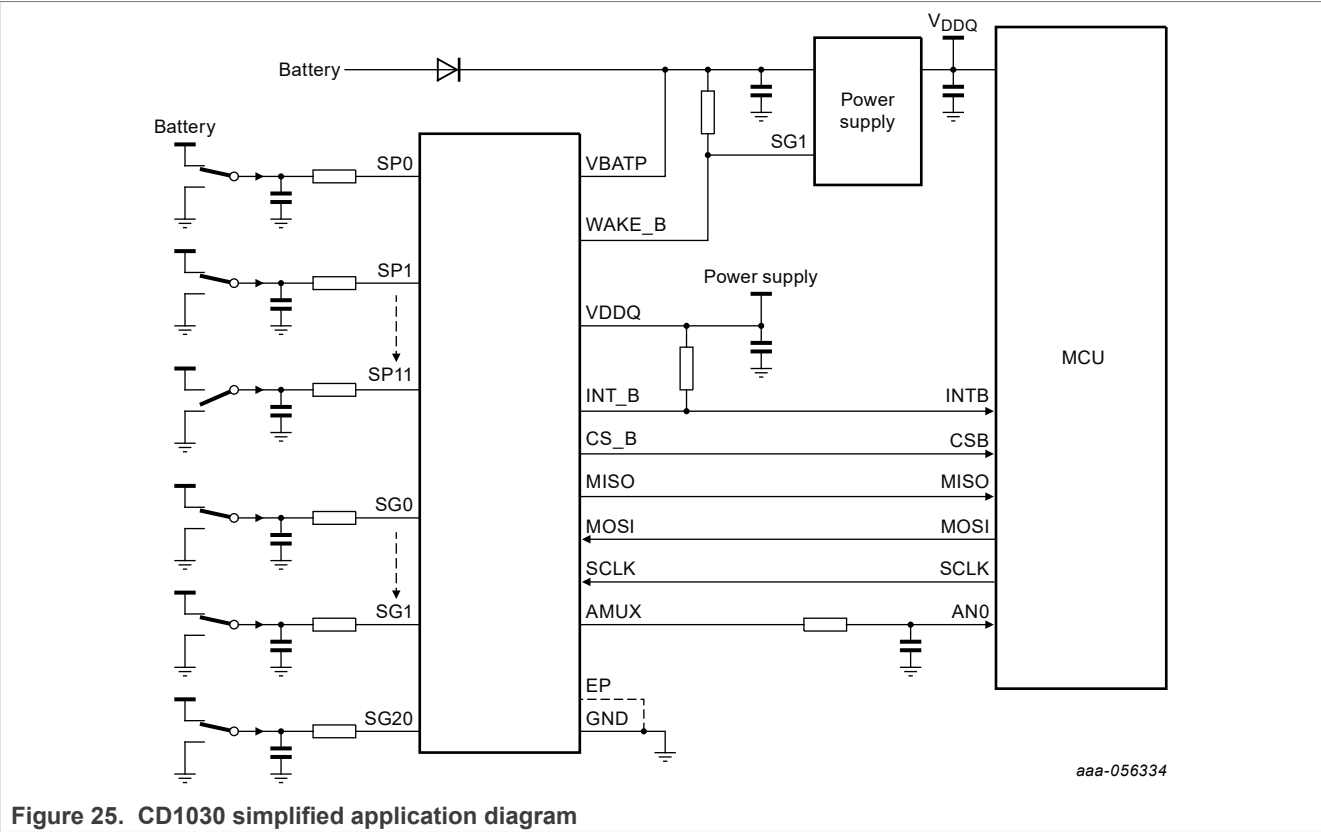


Figure 25. CD1030 simplified application diagram

10.4 Abnormal operation

The CD1030 could be subject to various conditions considered abnormal as defined within this section.

10.4.1 Reverse battery

This device with applicable external components is not damaged by exposure to reverse battery conditions of -14 V. This test is performed for a period of one minute at 25 °C. In addition, this negative voltage condition does not force any of the logic level I/O pins to a negative voltage less than -0.6 V at 10 mA or to a positive voltage greater than 5.0 V. This ensures protection of the digital device interfacing with this device.

10.4.2 Ground offset

The applicable driver outputs and/or current sense inputs are capable of operation with a ground offset of ± 1.0 V. The device is not damaged by exposure to this condition and maintains specified functionality.

10.4.3 Shorts to ground

All I/Os of the device that are available at the module connector are protected against shorts to ground with maximum ground offset considered (-1.0 V referenced to device ground or other application specific value). The device is not damaged by this condition.

10.4.4 Shorts to battery

All I/Os of the device available at the module connector are protected against a short to battery (voltage value is application dependent, although there may be cases where short to jump start or load dump voltage values are required). The device is not damaged by this condition.

10.4.5 Unpowered shorts to battery

All I/Os of the device available at the module connector are protected against unpowered (battery to the module is open) shorts to battery per application specifics. The device is not damaged by this condition, and does not enable any outputs nor backfeed onto the power rails (VBATP, VDDQ) or the digital I/O pins.

10.4.6 Loss of module ground

The definition of a loss of ground condition at the device level is all pins of the IC detects very low-impedance to battery. The nomenclature is suited to a test environment. In the application, a loss of ground condition results in all I/O pins floating to battery voltage, while all externally referenced I/O pins are at worst case pulled to ground. All applicable driver outputs and current sense inputs are protected against excessive leakage current due to loads referenced to an external ground (high-side drivers).

10.4.7 Loss of module battery

The loss of battery condition at the parts level is the power input pins of the IC see infinite impedance to the battery supply voltage (depending upon the application), but there is some undefined impedance looking from these pins to ground. All applicable driver outputs and current sense inputs are protected against excessive leakage current due to loads referenced to an external battery connection (low-side drivers).

11 Packaging

11.1 Package mechanical dimensions

Package dimensions are provided in package drawings. To find the most current package outline drawing, go to www.nxp.com and perform a keyword search for the drawing's document number.

Table 55. Packaging information

| Package | Suffix | Package outline drawing number |
|----------------|--------|--------------------------------|
| 48-Pin LQFP-EP | AE | 98ASA00173D |

11.2 Package drawing

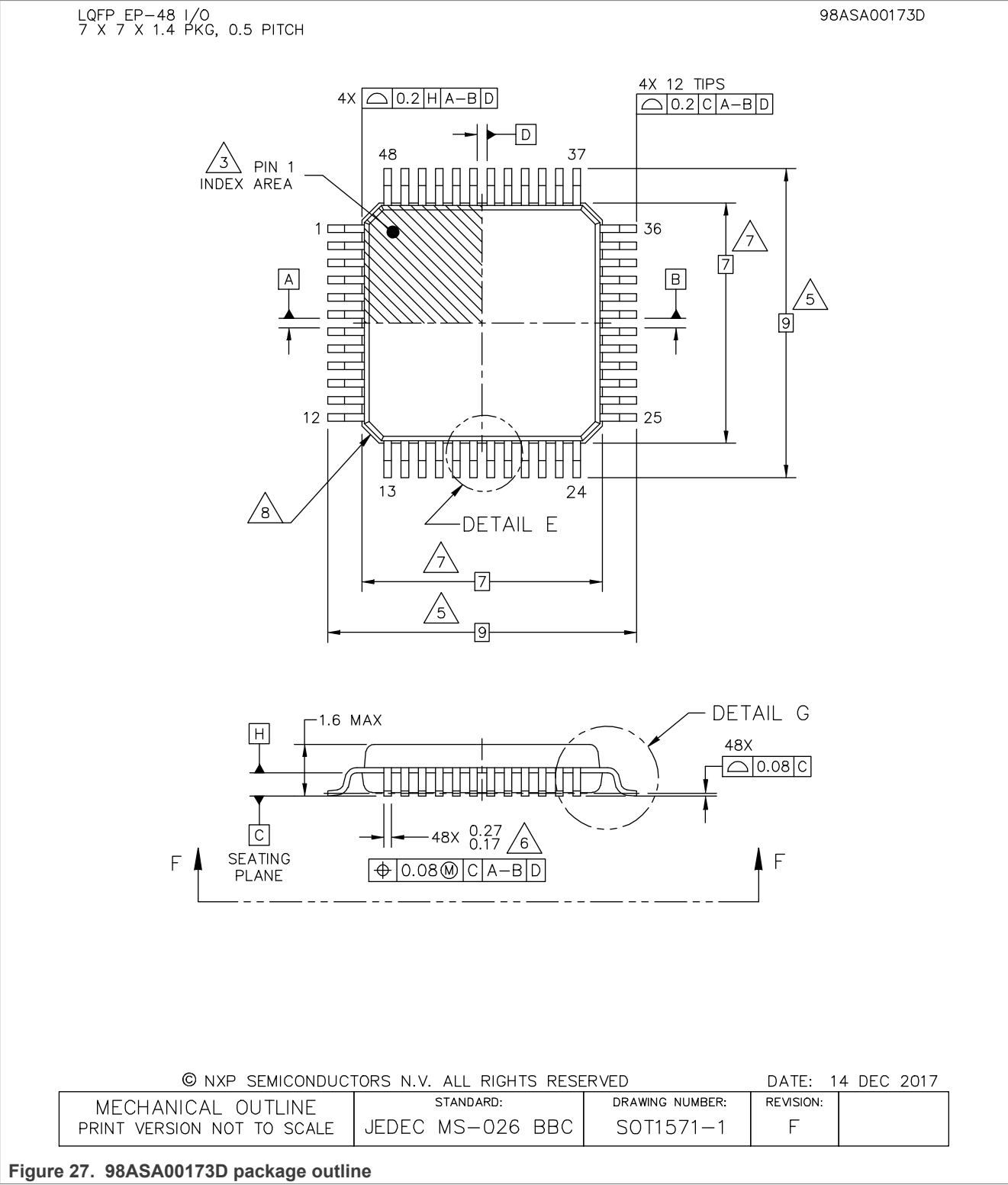
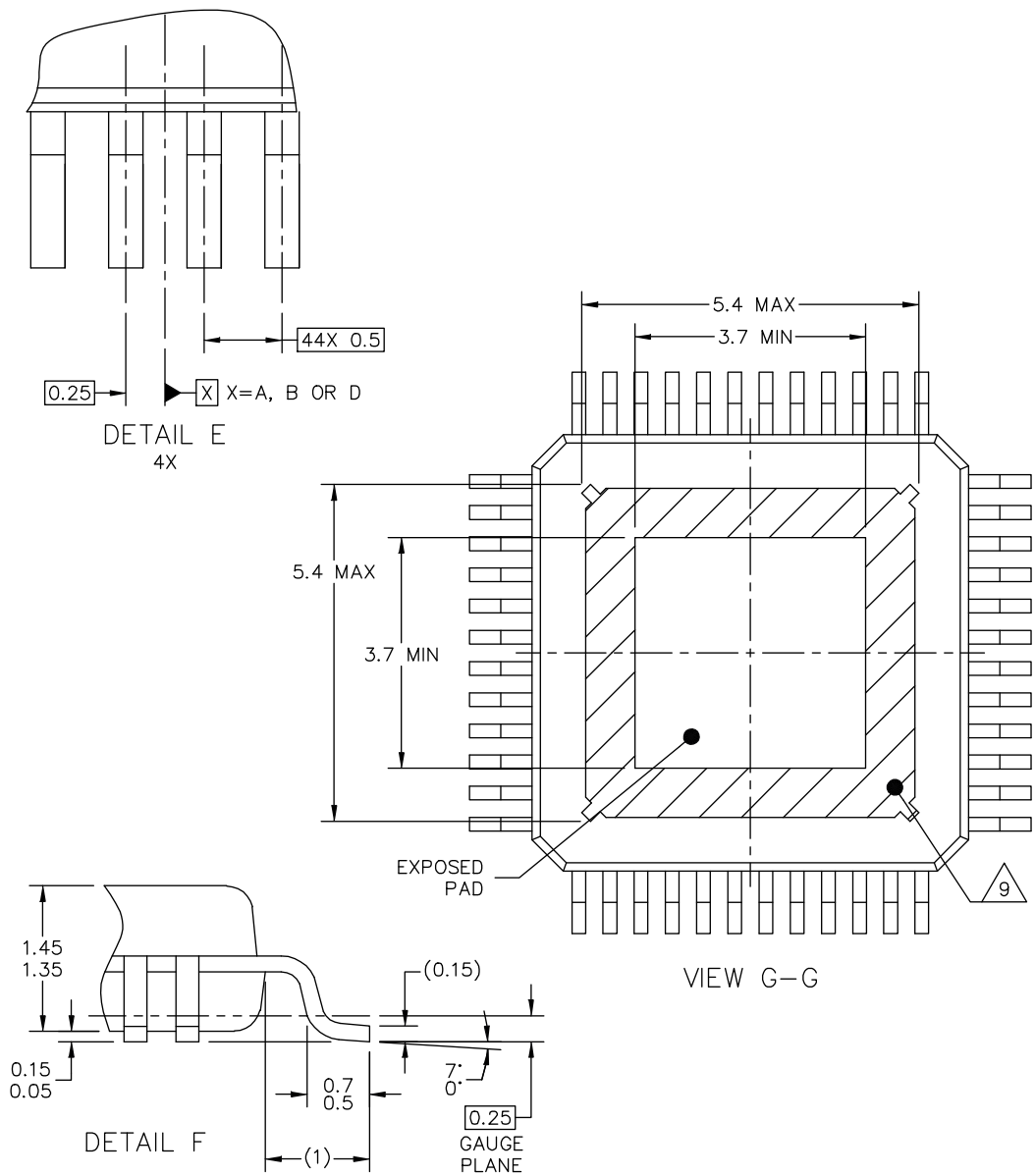


Figure 27. 98ASA00173D package outline

LQFP_EP-48 I/O
7 X 7 X 1.4 PKG, 0.5 PITCH

98ASA00173D



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DATE: 14 DEC 2017

| | | | | |
|--|-------------------------------|------------------------------|----------------|--|
| MECHANICAL OUTLINE PRINT VERSION NOT TO SCALE | STANDARD: JEDEC MS-026 BBC | DRAWING NUMBER: SOT1571-1 | REVISION: F | |
|--|-------------------------------|------------------------------|----------------|--|

Figure 28. 98ASA00173D detail

33-channel multiple switch detection interface with programmable wetting current

LQFP_EP-48 I/O
7 X 7 X 1.4 PKG, 0.5 PITCH

98ASA00173D

NOTES:

- 1. DIMENSIONS ARE IN MILLIMETERS.
- 2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
- 3. PIN 1 FEATURE SHAPE, SIZE AND LOCATION MAY VARY.
- 4. DATUMS A, B AND D TO BE DETERMINED AT DATUM PLANE H.
- 5. DIMENSION TO BE DETERMINED AT SEATING PLANE C.
- 6. THIS DIMENSION DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL NOT CAUSE THE LEAD WIDTH TO EXCEED THE UPPER LIMIT BY MORE THAN 0.08MM AT MAXIMUM MATERIAL CONDITION. DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OR THE FOOT. MINIMUM SPACE BETWEEN PROTRUSION AND ADJACENT LEAD SHALL NOT BE LESS THAN 0.07MM.
- 7. THIS DIMENSION DOES NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS 0.25MM PER SIDE. THIS DIMENSION IS MAXIMUM PLASTIC BODY SIZE DIMENSION INCLUDING MOLD MISMATCH.
- 8. EXACT SHAPE OF EACH CORNER IS OPTIONAL.
- 9. HATCHED AREA TO BE KEEP OUT ZONE FOR PCB ROUTING.

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| | | | | |
|--|-------------------------------|------------------------------|----------------|--|
| MECHANICAL OUTLINE PRINT VERSION NOT TO SCALE | STANDARD: JEDEC MS-026 BBC | DRAWING NUMBER: SOT1571-1 | REVISION: F | |
|--|-------------------------------|------------------------------|----------------|--|

Figure 29. 98ASA00173D notes

12 Reference section

Table 56. CD1030 reference documents

| Reference | Description |
|--------------|--|
| CDF-AEC-Q100 | Stress Test Qualification For Automotive Grade Integrated Circuits |
| Q-1000 | Qualification Specification for Integrated Circuits |
| SQ-1001 | Specification Conformance |

13 Revision history

| Revision | Date | Description |
|----------|----------------|--|
| 6.0 | 20 August 2024 | <ul style="list-style-type: none"> • CIN 202407013I • Corrected Section 1 to include Polling state • Replaced all instances of <i>master</i> with <i>primary</i> or <i>primary device</i> <ul style="list-style-type: none"> – Section 8.8.2 (two instances) – Section 8.8.4 (one instance) • Replaced all instances of <i>slave</i> with <i>secondary</i> or <i>secondary device</i> <ul style="list-style-type: none"> – Section 6.2 (two instances) – Section 8.8 (one instance) • Updated format and organization to match current NXP template • Updated Section 11.2 to rev F • Updated legal information |
| 5.0 | July 2018 | <ul style="list-style-type: none"> • Changed document status from Advance Information to Technical Data |
| 4.0 | March 2017 | <ul style="list-style-type: none"> • Corrected typo in Figure 2 • Added Note 2 to switch input voltage range in Table 3 |
| 3.0 | January 2016 | <ul style="list-style-type: none"> • Relaxed AMUX offset specification to ± 15 mV • Updated Figure 16 to clarify LPM operation • Clarified 20% tolerance for SB wetting current in LV condition • Corrected MISO operation description, the CD1030 also shift data out on the Falling edge of SCLK • Deleted PC34CD1030AE from the Orderable Part Variations table |
| 2.0 | July 2015 | <ul style="list-style-type: none"> • Deleted statement: Short to ground is detectable by internal diagnostics • Deleted statement: Short to battery is detectable by internal diagnostics • Changed test conditions on $I_{\text{POLLING,IQ}}$ to make sure the worst case is being considered (3.0 ms) • Added Note 13 and Note 14 to clarify LPM current specification • VDDQ bulk capacitor marked a 10 μF typical value if required by the application • Updated $I_{\text{BATP(ON)}}$ to Typ = 12 mA, Max = 16 mA • Clarified WAKE_B operation • Updated VBATP HBM specification to 4.0 KV |
| 1.0 | July 2015 | <ul style="list-style-type: none"> • Initial Release |

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| Document status ^{[1][2]} | Product status ^[3] | Definition |
|-----------------------------------|-------------------------------|---|
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[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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